

# EE 330

## Lecture 27

### Small-Signal Analysis

- Graphical Interpretation
- MOSFET Model Extensions
- Biasing (a precursor)

### Two-Port Amplifier Modeling

# Exam Schedule

Exam 2 will be given on Friday March 11

Exam 3 will be given on Friday April 15

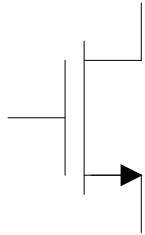
Photo courtesy of the director of the National Institute of Health ( NIH)



As a courtesy to fellow classmates, TAs, and the instructor

**Wearing of masks during lectures and in the laboratories for this course would be appreciated irrespective of vaccination status**

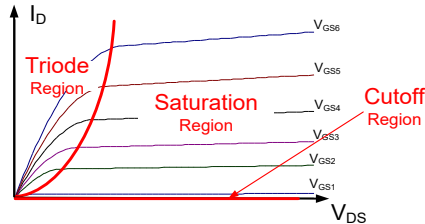
# Small Signal Model of MOSFET



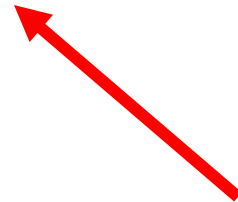
Large Signal Model

$$I_G = 0$$

3-terminal device



$$I_D = \begin{cases} 0 & V_{GS} \leq V_T \\ \mu C_{OX} \frac{W}{L} \left( V_{GS} - V_T - \frac{V_{DS}}{2} \right) V_{DS} & V_{GS} \geq V_T, V_{DS} < V_{GS} - V_T \\ \mu C_{OX} \frac{W}{2L} (V_{GS} - V_T)^2 (1 + \lambda V_{DS}) & V_{GS} \geq V_T, V_{DS} \geq V_{GS} - V_T \end{cases}$$



*MOSFET is usually operated in saturation region in linear applications where a small-signal model is needed so will develop the small-signal model in the saturation region*

# Small Signal Model of MOSFET

## Saturation Region Summary

*Nonlinear model:*

$$\left\{ \begin{array}{l} I_G = 0 \\ I_D = \mu C_{\text{ox}} \frac{W}{2L} (V_{\text{GS}} - V_T)^2 (1 + \lambda V_{\text{DS}}) \end{array} \right.$$

*Small-signal model:*

$$\left\{ \begin{array}{l} i_G = y_{11} v_{\text{GS}} + y_{12} v_{\text{DS}} = 0 \\ i_D = y_{21} v_{\text{GS}} + y_{22} v_{\text{DSE}} \end{array} \right.$$

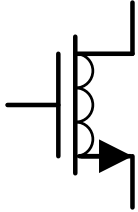
$$y_{11} = 0$$

$$y_{12} = 0$$

$$y_{21} = g_m \cong \mu C_{\text{ox}} \frac{W}{L} (V_{\text{GSQ}} - V_T)$$

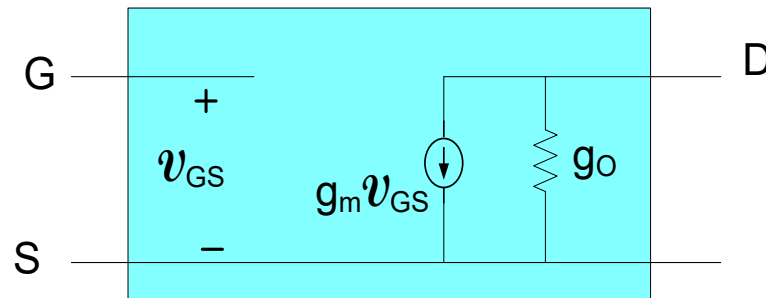
$$y_{22} = g_0 \cong \lambda I_{\text{DQ}}$$

# Small-Signal Model of MOSFET



$$g_m = \mu C_{\text{ox}} \frac{W}{L} (V_{\text{GSQ}} - V_T)$$

$$g_o \cong \lambda I_{\text{DQ}}$$



*Alternate equivalent expressions for  $g_m$ :*

$$I_{\text{DQ}} = \mu C_{\text{ox}} \frac{W}{2L} (V_{\text{GSQ}} - V_T)^2 (1 + \lambda V_{\text{DSQ}}) \cong \mu C_{\text{ox}} \frac{W}{2L} (V_{\text{GSQ}} - V_T)^2$$

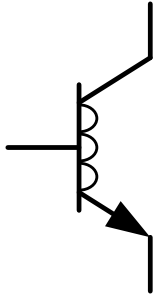
$$g_m = \mu C_{\text{ox}} \frac{W}{L} (V_{\text{GSQ}} - V_T)$$

$$g_m = \sqrt{2\mu C_{\text{ox}} \frac{W}{L}} \cdot \sqrt{I_{\text{DQ}}}$$

$$g_m = \frac{2I_{\text{DQ}}}{V_{\text{GSQ}} - V_T}$$

Review from last lecture

# Small Signal Model of BJT



$$\begin{aligned} i_B &= y_{11} v_{BE} + y_{12} v_{CE} \\ i_C &= y_{21} v_{BE} + y_{22} v_{CE} \end{aligned}$$

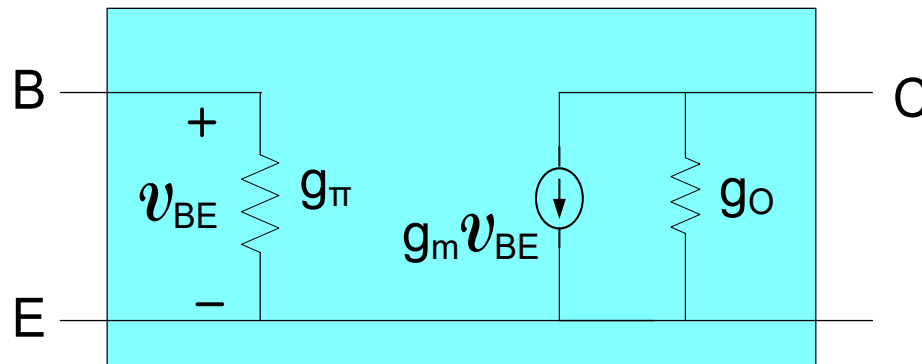


$$\begin{aligned} i_B &= g_\pi v_{BE} \\ i_C &= g_m v_{BE} + g_o v_{CE} \end{aligned}$$

$$g_\pi = \frac{I_{CQ}}{\beta V_t}$$

$$g_m = \frac{I_{CQ}}{V_t}$$

$$g_o = \frac{I_{CQ}}{V_{AF}}$$

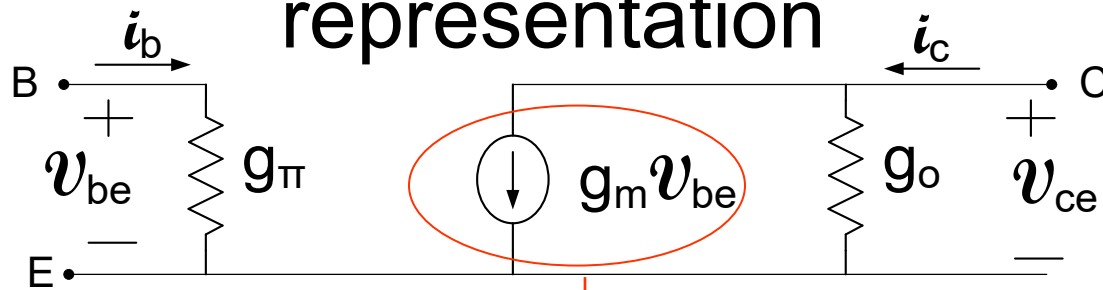


An equivalent circuit

y-parameter model using “g” parameter notation

Review from last lecture

# Small Signal BJT Model – alternate representation



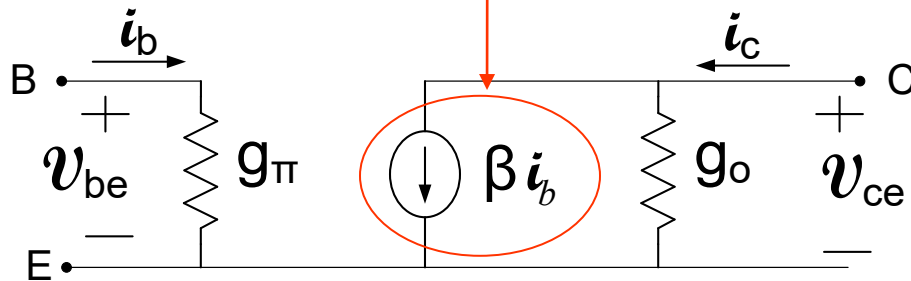
$$g_m = \frac{I_{CQ}}{V_t}$$

$$g_\pi = \frac{I_{CQ}}{\beta V_t}$$

$$g_o \cong \frac{I_{CQ}}{V_{AF}}$$

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Alternate equivalent small signal model



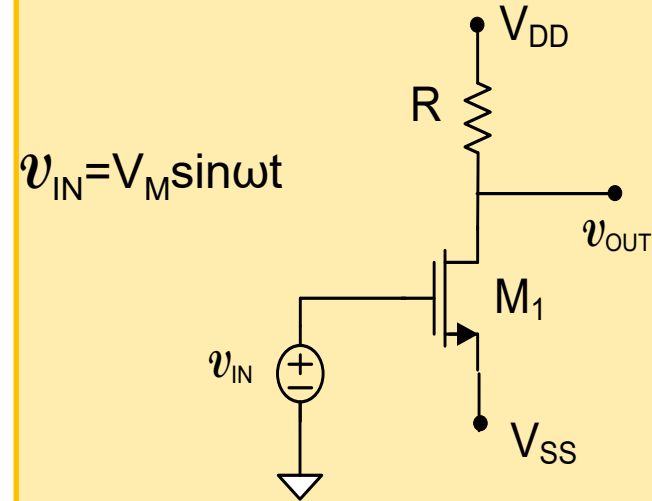
$$g_\pi = \frac{I_{CQ}}{\beta V_t}$$

$$g_o \cong \frac{I_{CQ}}{V_{AF}}$$



Consider again: *Review from last lecture*

# Small-signal analysis example

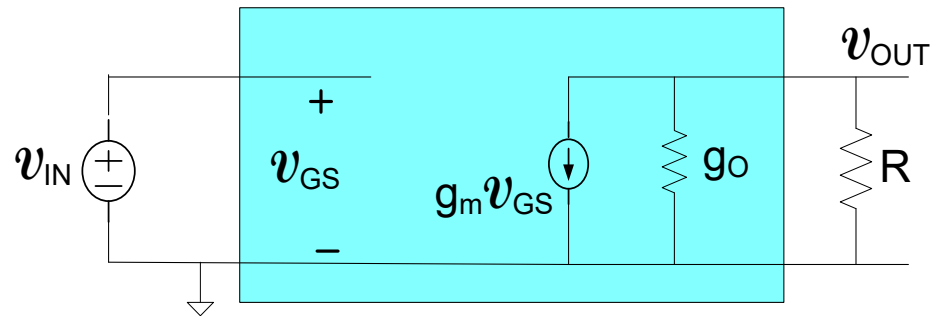
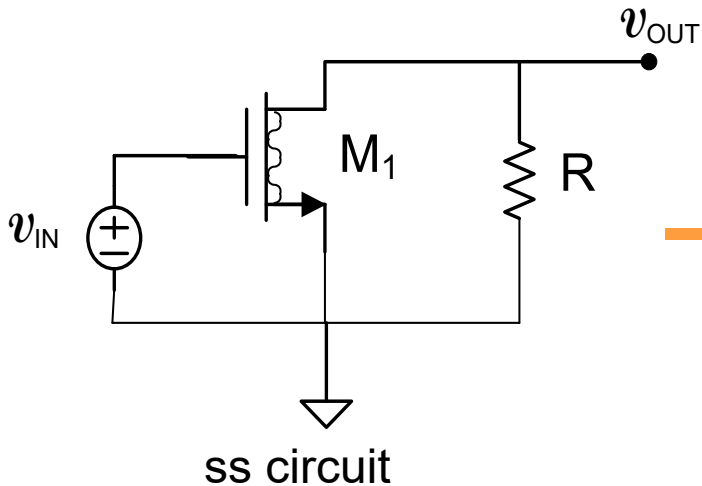


$$A_v = \frac{2I_{DQ} R}{[V_{SS} + V_T]}$$

Derived for  $\lambda=0$  (equivalently  $g_o=0$ )

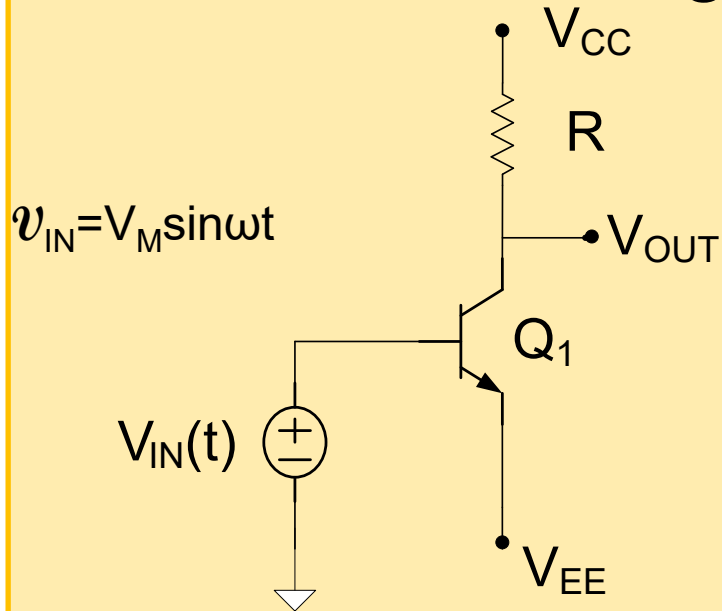
$$I_D = \mu C_{ox} \frac{W}{2L} (V_{GS} - V_T)^2$$

Recall the derivation was very tedious and time consuming!



Consider again: *Review from last lecture*

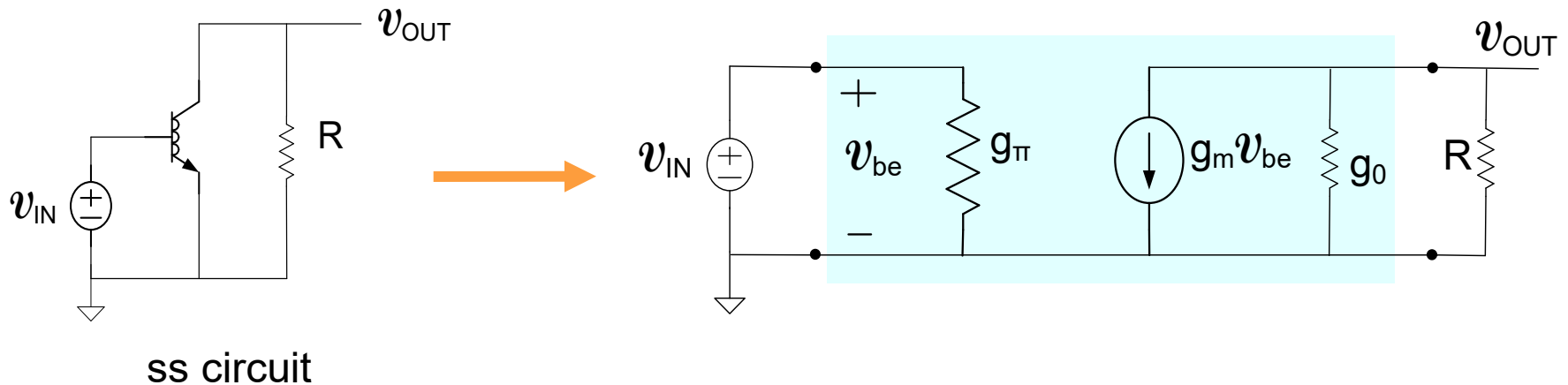
# Small signal analysis example



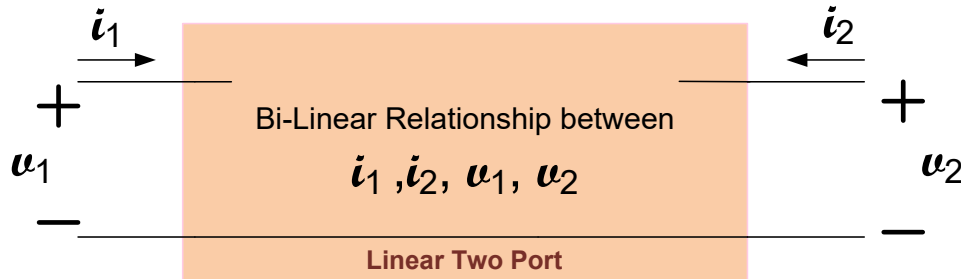
$$A_{vB} = -\frac{I_{CQ} R}{V_t}$$

Derived for  $V_{AF}=0$  (equivalently  $g_o=0$ )

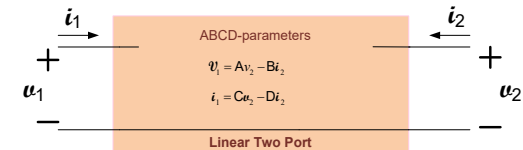
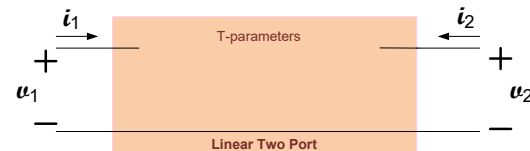
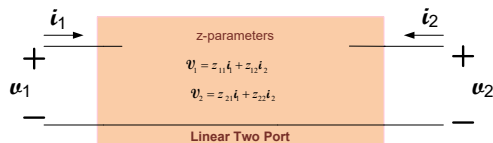
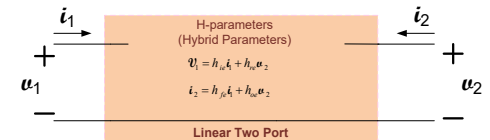
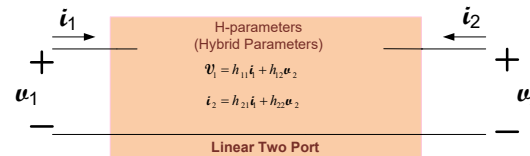
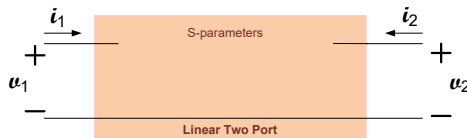
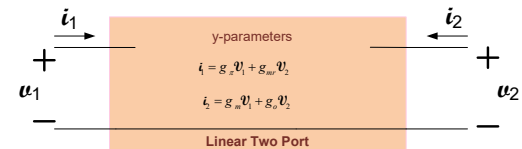
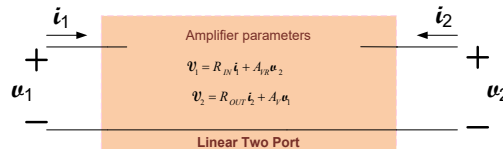
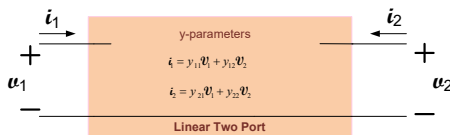
Recall the derivation was very tedious and time consuming!



# Small-Signal Model Representations



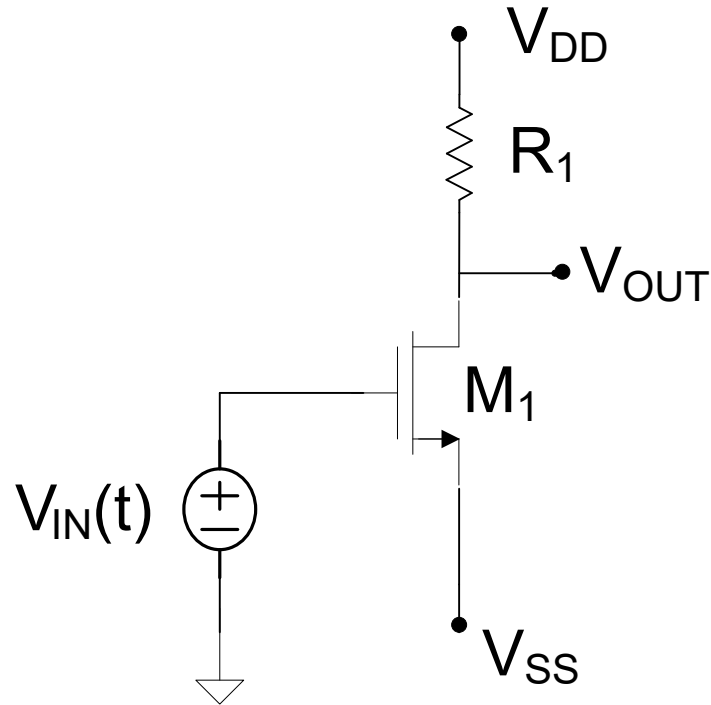
The good, the bad, and the **unnecessary** !!



- Equivalent circuits often given for each representation
- All provide identical characterization
- Easy to move from any one to another

# Graphical Analysis and Interpretation

Consider Again



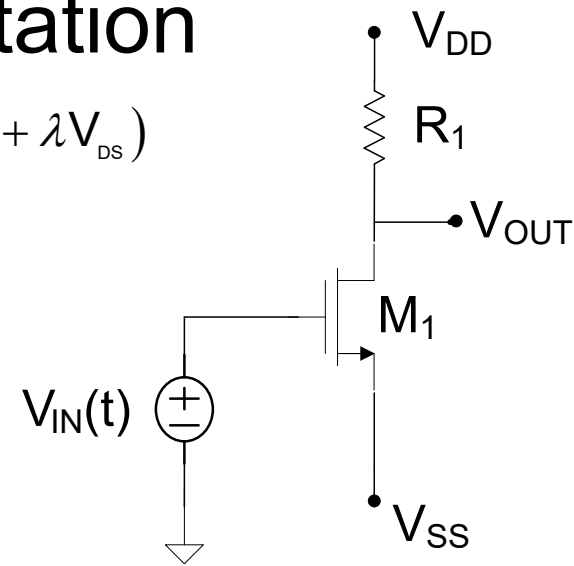
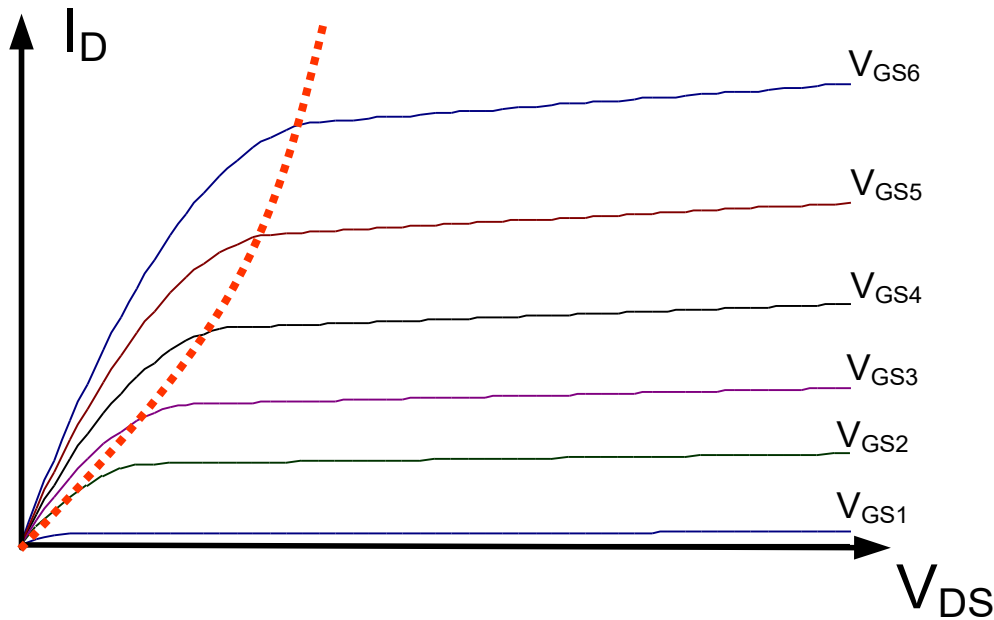
$$V_{OUT} = V_{DD} - I_D R$$

$$I_D = \frac{\mu C_{OX} W}{2L} (V_{IN} - V_{SS} - V_T)^2$$

$$I_{DQ} = \frac{\mu C_{OX} W}{2L} (V_{SS} + V_T)^2$$

# Graphical Analysis and Interpretation

Device Model (family of curves)  $I_D = \frac{\mu C_{ox} W}{2L} (V_{GS} - V_T)^2 (1 + \lambda V_{DS})$



Load Line



$$V_{OUT} = V_{DD} - I_D R$$

Device Model

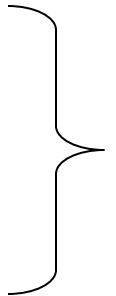


$$I_D = \frac{\mu C_{ox} W}{2L} (V_{IN} - V_{SS} - V_T)^2$$

Device Model at Operating Point

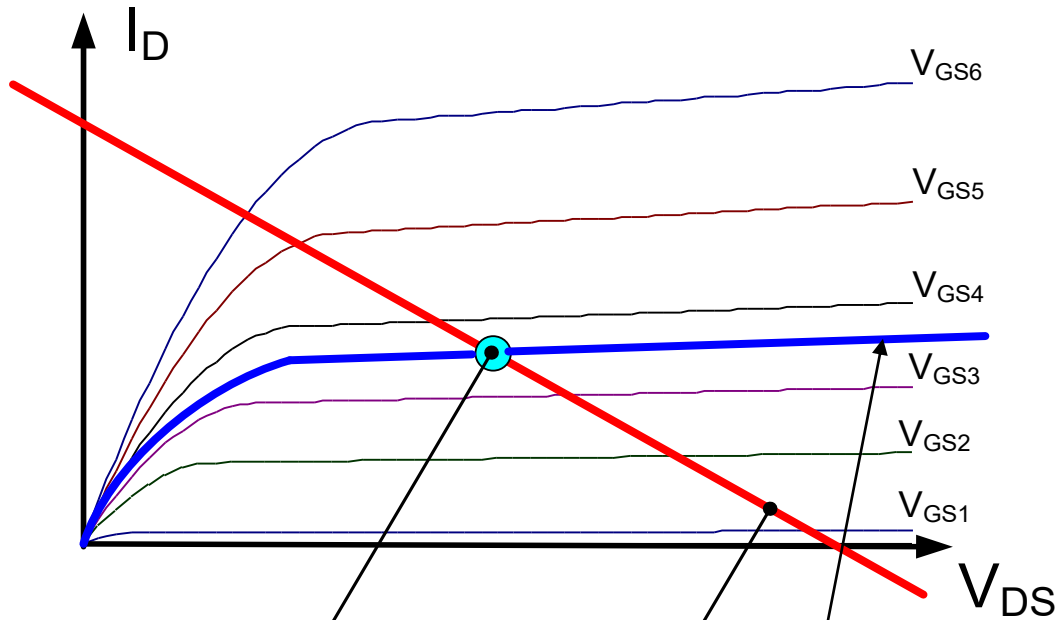


$$I_{DQ} = \frac{\mu C_{ox} W}{2L} (V_{SS} + V_T)^2$$



# Graphical Analysis and Interpretation

Device Model (family of curves)  $I_D = \frac{\mu C_{ox} W}{2L} (V_{GS} - V_T)^2 (1 + \lambda V_{DS})$



$$V_{GSQ} = -V_{SS}$$

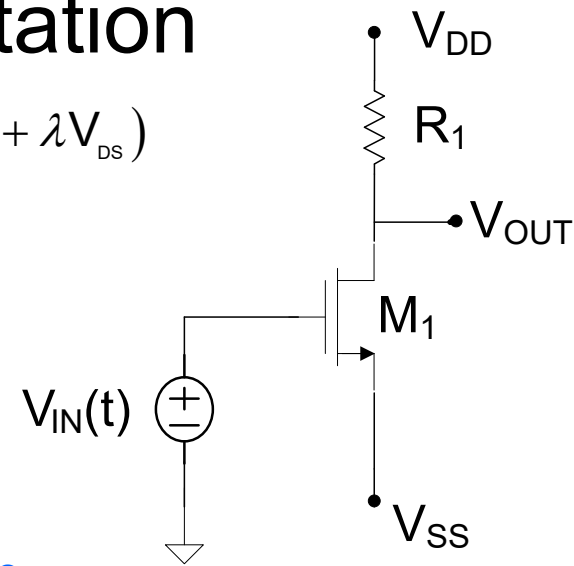
$$I_{DQ} \cong \frac{\mu C_{ox} W}{2L} (V_{SS} + V_T)^2$$

$$V_{GSQ} = -V_{SS}$$

Must satisfy both equations all of the time !

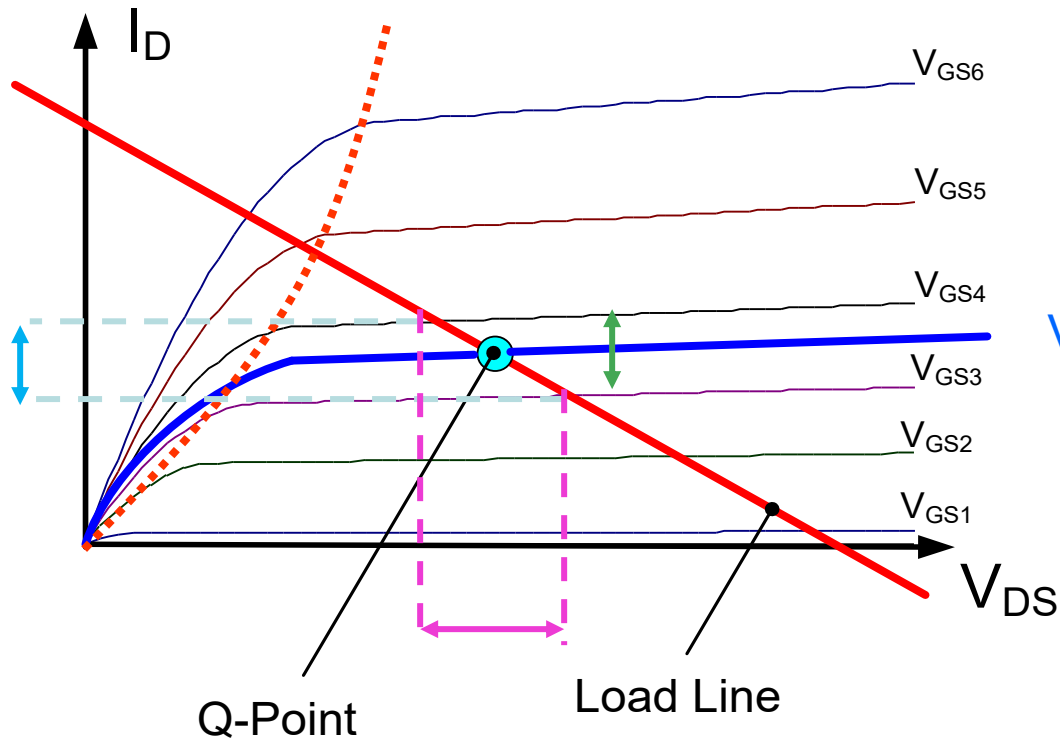
$$V_{OUT} = V_{DD} - I_D R$$

$$I_D = \frac{\mu C_{ox} W}{2L} (V_{IN} - V_{SS} - V_T)^2 \quad ?$$

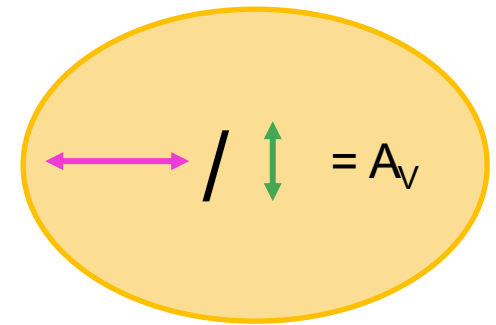
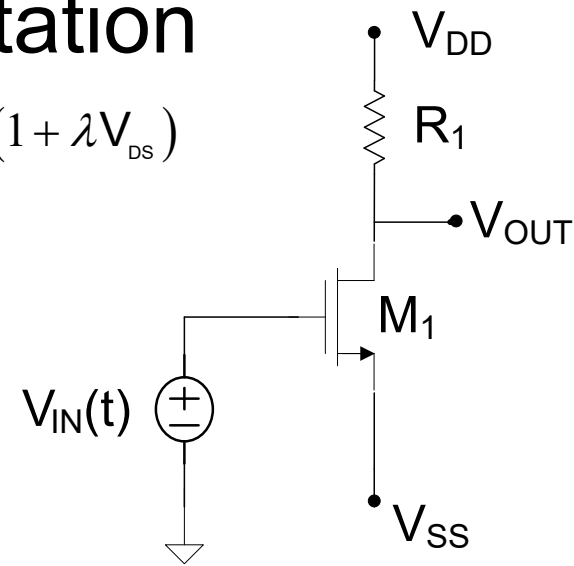


# Graphical Analysis and Interpretation

Device Model (family of curves) 
$$I_D = \frac{\mu C_{ox} W}{2L} (V_{IN} - V_{SS} - V_T)^2 (1 + \lambda V_{DS})$$



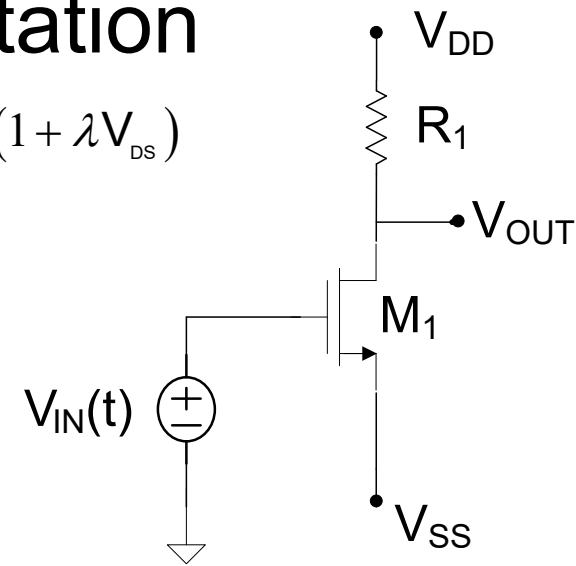
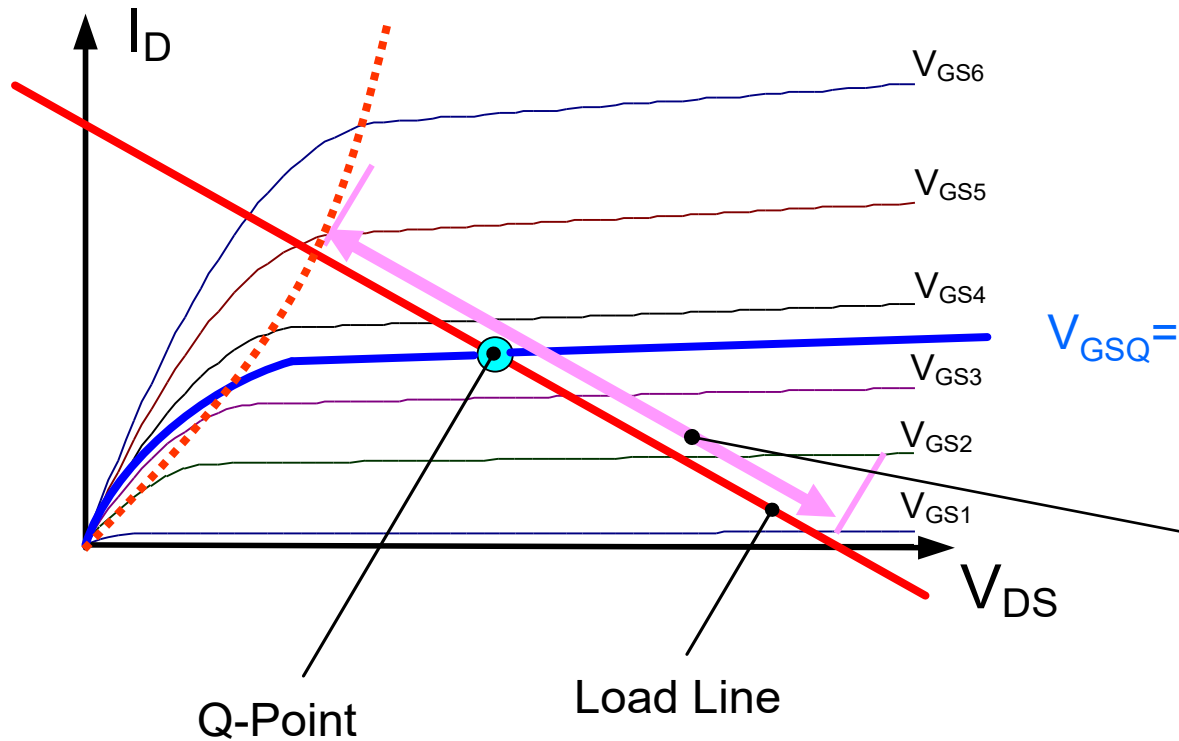
$$V_{GSQ} = -V_{SS}$$



- As  $V_{IN}$  changes around Q-point,  $V_{IN}$  induces changes in  $V_{GS}$ . The operating point must remain on the load line!
- Small sinusoidal changes of  $V_{IN}$  will be nearly symmetric around the  $V_{GSQ}$  line
- This will cause nearly symmetric changes in both  $I_D$  and  $V_{DS}$  !
- Since  $V_{SS}$  is constant, change in  $V_{DS}$  is equal to change in  $V_{OUT}$

# Graphical Analysis and Interpretation

Device Model (family of curves)  $I_D = \frac{\mu C_{ox} W}{2L} (V_{IN} - V_{SS} - V_T)^2 (1 + \lambda V_{DS})$



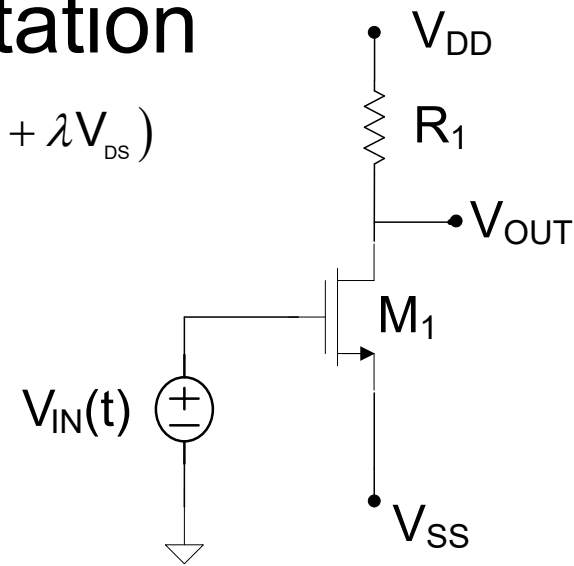
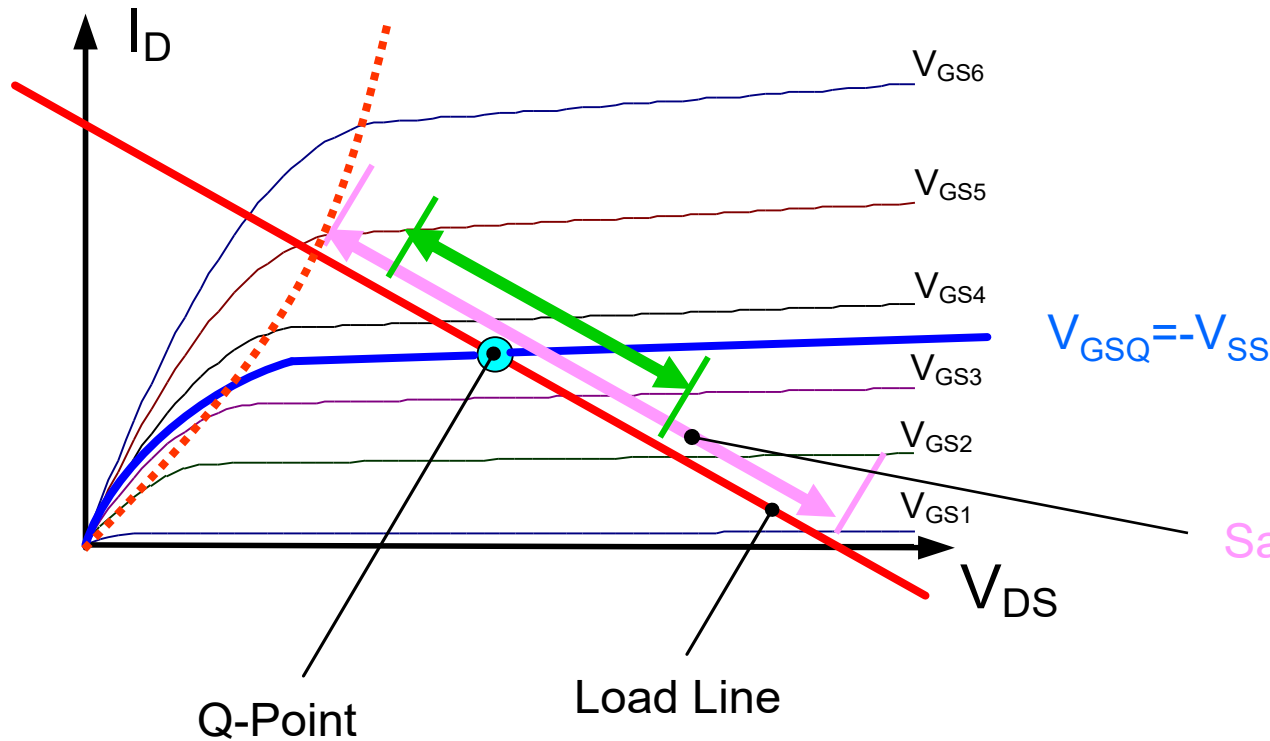
$$I_{DQ} \cong \frac{\mu C_{ox} W}{2L} (V_{SS} + V_T)^2$$

As  $V_{IN}$  changes around Q-point, due to changes  $V_{IN}$  induces in  $V_{GS}$ , the operating point must remain on the load line!



# Graphical Analysis and Interpretation

Device Model (family of curves) 
$$I_{DQ} = \frac{\mu C_{ox} W}{2L} (V_{GS} - V_T)^2 (1 + \lambda V_{DS})$$

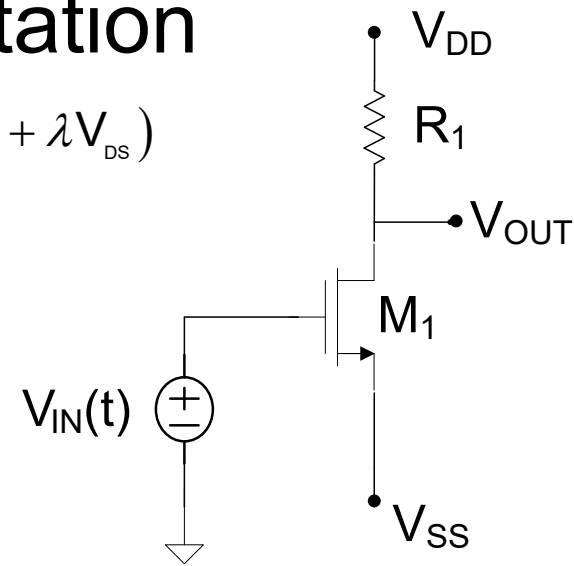
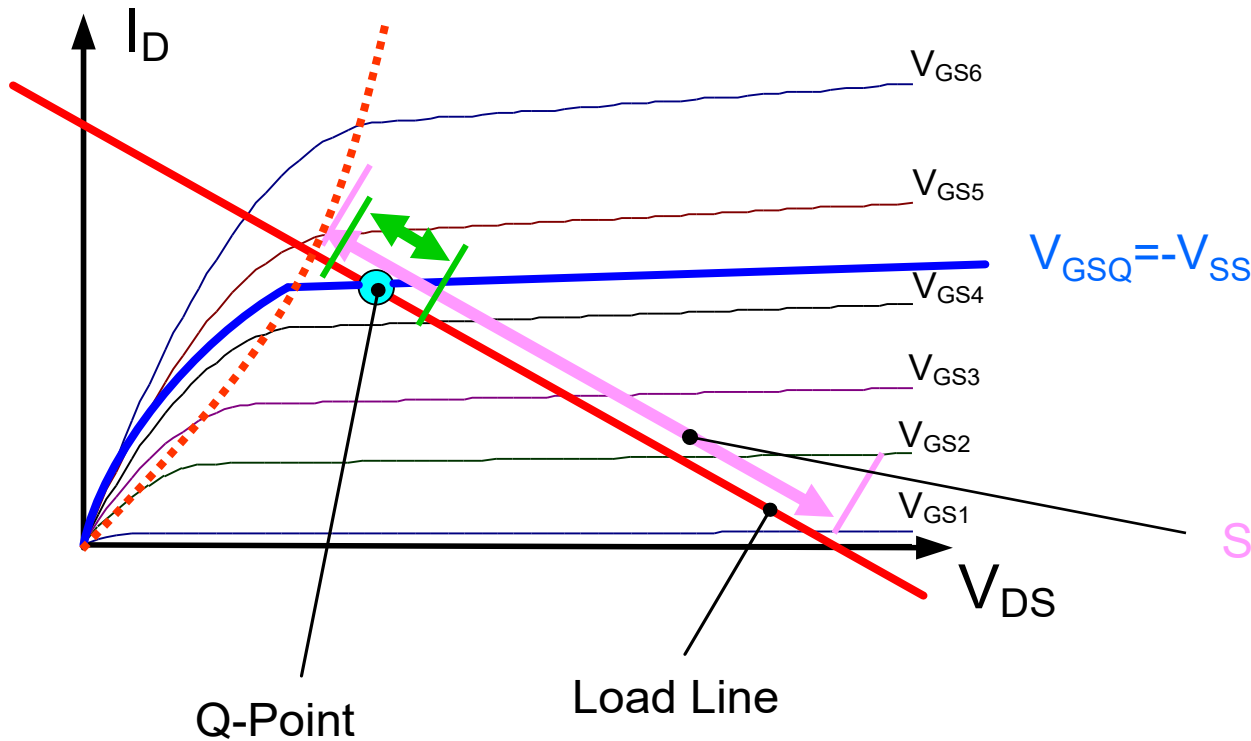


$$I_{DQ} \cong \frac{\mu C_{ox} W}{2L} (V_{SS} + V_T)^2$$

- Linear signal swing region smaller than saturation region
- Modest nonlinear distortion provided saturation region operation maintained
- Symmetric swing about Q-point
- Signal swing can be maximized by judicious location of Q-point

# Graphical Analysis and Interpretation

Device Model (family of curves) 
$$I_{DQ} = \frac{\mu C_{ox} W}{2L} (V_{GS} - V_T)^2 (1 + \lambda V_{DS})$$



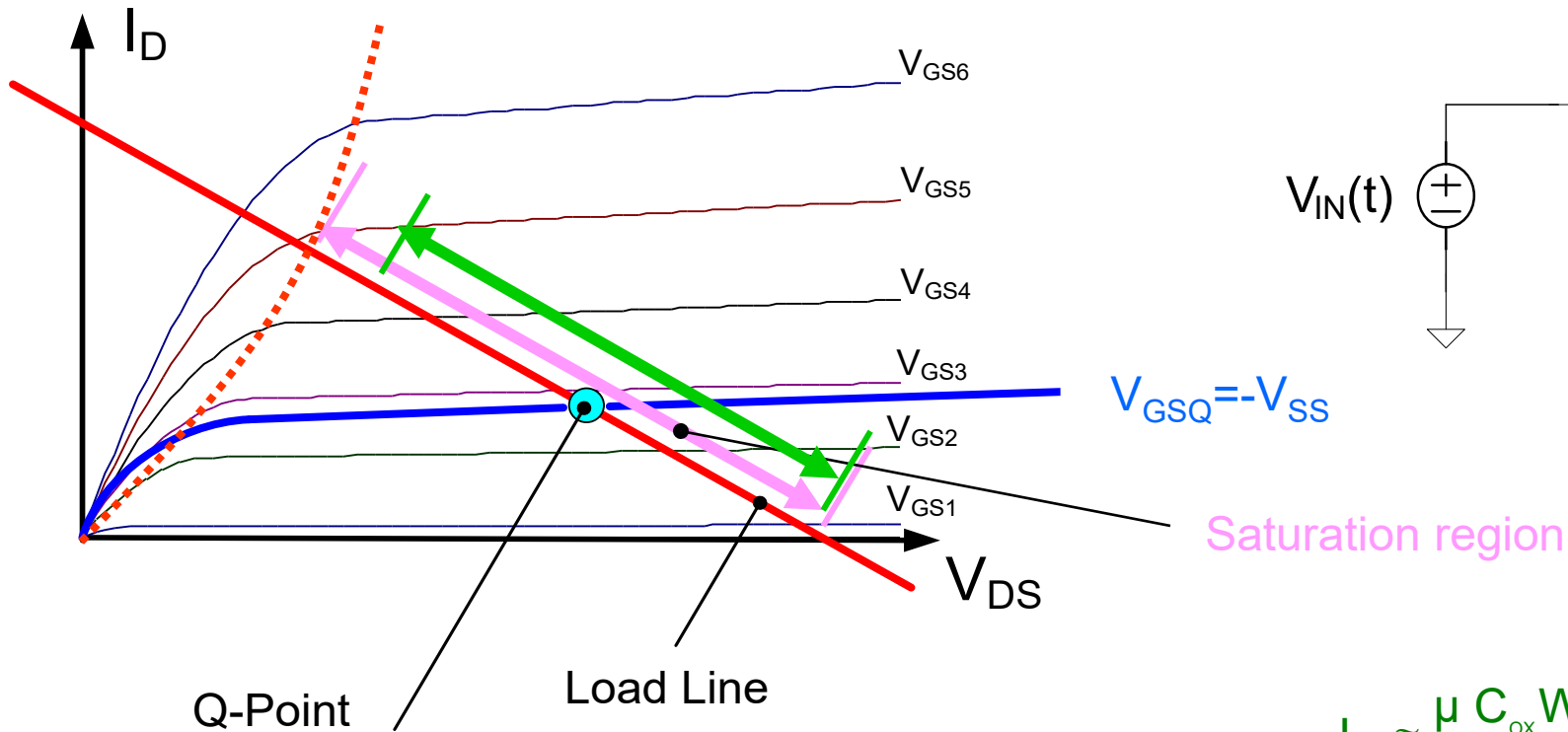
Saturation region

$$I_{DQ} \cong \frac{\mu C_{ox} W}{2L} (V_{SS} + V_T)^2$$

Very limited signal swing with non-optimal Q-point location

# Graphical Analysis and Interpretation

Device Model (family of curves) 
$$I_{DQ} = \frac{\mu C_{ox} W}{2L} (V_{GS} - V_T)^2 (1 + \lambda V_{DS})$$



$$I_{DQ} \cong \frac{\mu C_{ox} W}{2L} (V_{SS} + V_T)^2$$

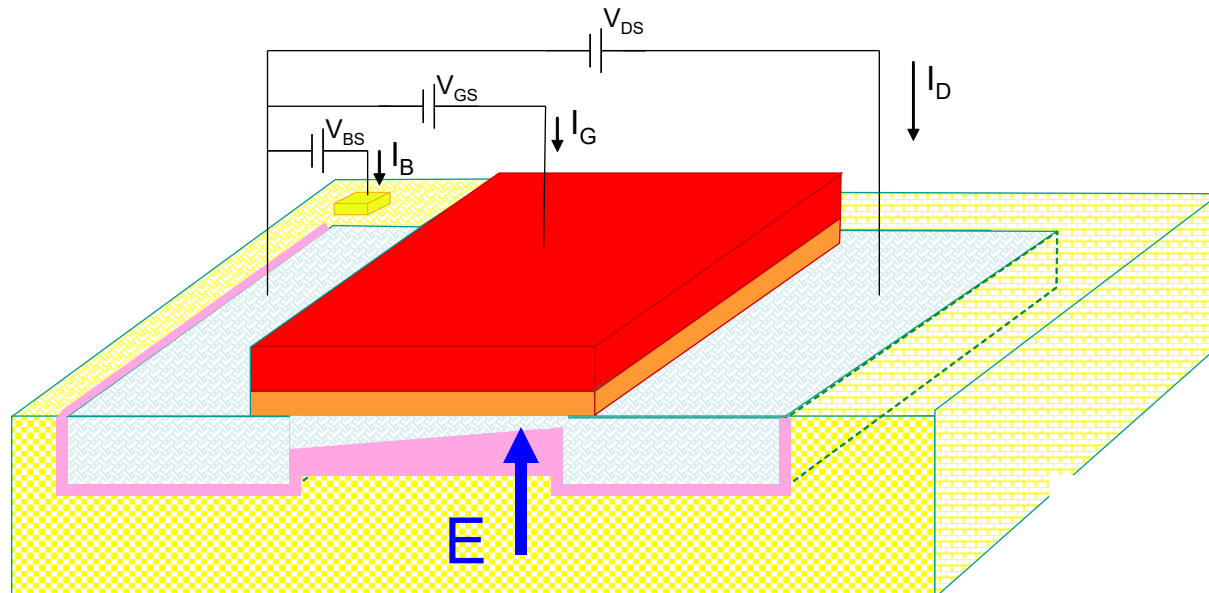
- Signal swing can be maximized by judicious location of Q-point
- Often selected to be at middle of load line in saturation region

# Small-Signal MOSFET Model Extension

Existing 3-terminal small-signal model does not depend upon the bulk voltage !



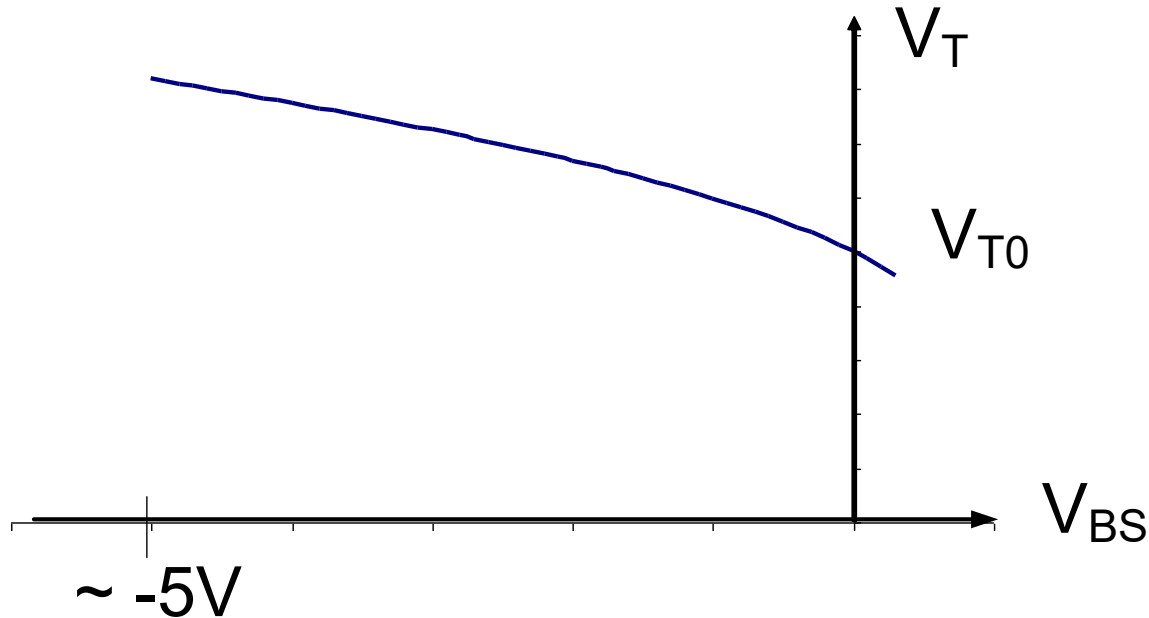
**Recall** that changing the bulk voltage changes the electric field in the channel region and thus the threshold voltage!



## Recall: Typical Effects of Bulk on Threshold Voltage for n-channel Device

$$V_T = V_{T0} + \gamma \left[ \sqrt{\phi - V_{BS}} - \sqrt{\phi} \right]$$

$$\gamma \cong 0.4V^{-\frac{1}{2}} \quad \phi \cong 0.6V$$



Bulk-Diffusion Generally Reverse Biased ( $V_{BS} < 0$  or at least less than 0.3V) for n-channel

Shift in threshold voltage with bulk voltage can be substantial

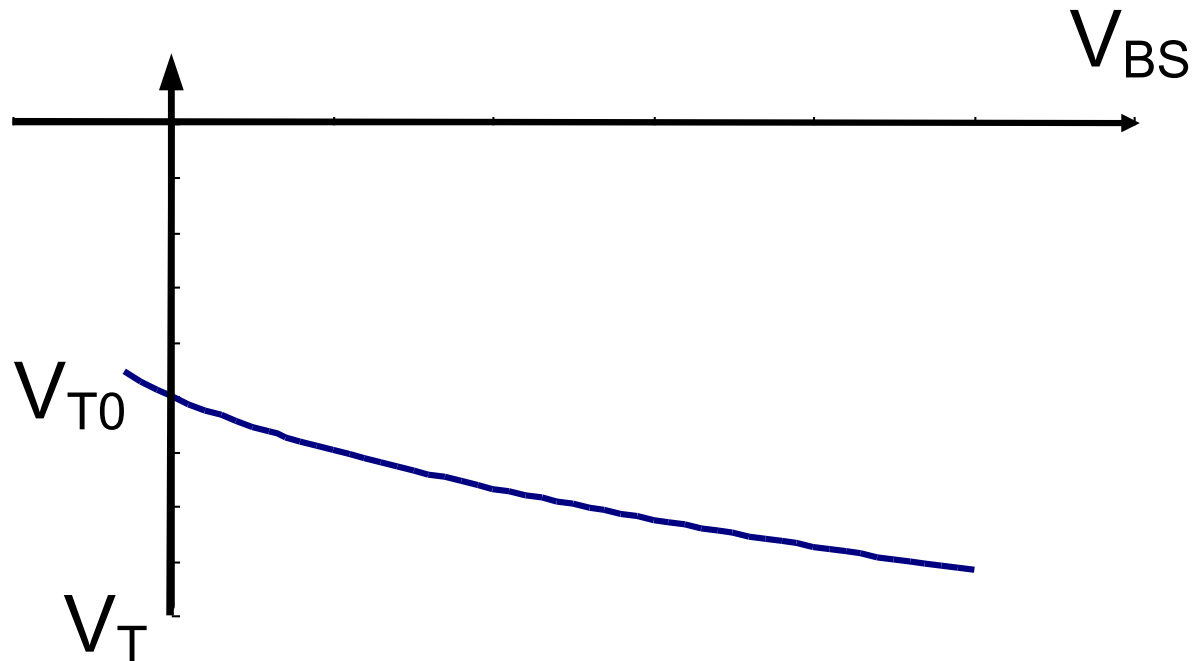
Often  $V_{BS} = 0$

**Recall:** Typical Effects of Bulk on Threshold Voltage for p-channel Device

$$V_T = V_{T0} - \gamma \left[ \sqrt{\phi + V_{BS}} - \sqrt{\phi} \right]$$

$$\gamma \cong 0.4V^{-\frac{1}{2}}$$

$$\phi \cong 0.6V$$



Bulk-Diffusion Generally Reverse Biased ( $V_{BS} > 0$  or at least greater than  $-0.3V$ ) for n-channel

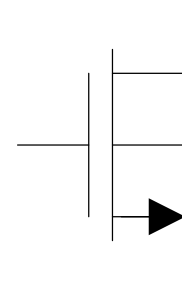
Same functional form as for n-channel devices but  $V_{T0}$  is now negative and the magnitude of  $V_T$  still increases with the magnitude of the reverse bias

Recall:

# 4-terminal model extension

$$I_G = 0$$

$$I_B = 0$$



$$I_D = \begin{cases} 0 & V_{GS} \leq V_T \\ \mu C_{OX} \frac{W}{L} \left( V_{GS} - V_T - \frac{V_{DS}}{2} \right) V_{DS} & V_{GS} \geq V_T \quad V_{DS} < V_{GS} - V_T \\ \mu C_{OX} \frac{W}{2L} (V_{GS} - V_T)^2 \cdot (1 + \lambda V_{DS}) & V_{GS} \geq V_T \quad V_{DS} \geq V_{GS} - V_T \end{cases}$$

$$V_T = V_{T0} + \gamma \left( \sqrt{\phi - V_{BS}} - \sqrt{\phi} \right)$$

Model Parameters :  $\{\mu, C_{OX}, V_{T0}, \phi, \gamma, \lambda\}$

Design Parameters :  $\{W, L\}$  but only one degree of freedom W/L  
biasing or quiescent point

# Small-Signal 4-terminal Model Extension

$$I_G = 0$$

$$I_B = 0$$

$$I_D = \begin{cases} 0 \\ \mu C_{\text{ox}} \frac{W}{L} \left( V_{\text{GS}} - V_T - \frac{V_{\text{DS}}}{2} \right) V_{\text{DS}} \end{cases}$$

$$V_{\text{GS}} \leq V_T$$

$$V_{\text{GS}} \geq V_T \quad V_{\text{DS}} < V_{\text{GS}} - V_T$$

$$\mu C_{\text{ox}} \frac{W}{2L} (V_{\text{GS}} - V_T)^2 \bullet (1 + \lambda V_{\text{DS}})$$

$$V_{\text{GS}} \geq V_T \quad V_{\text{DS}} \geq V_{\text{GS}} - V_T$$

$$V_T = V_{T0} + \gamma \left( \sqrt{\phi - V_{\text{BS}}} - \sqrt{\phi} \right)$$

$$y_{11} = \left. \frac{\partial I_G}{\partial V_{\text{GS}}} \right|_{\bar{V}=\bar{V}_Q} = 0 \quad y_{12} = \left. \frac{\partial I_G}{\partial V_{\text{DS}}} \right|_{\bar{V}=\bar{V}_Q} = 0 \quad y_{13} = \left. \frac{\partial I_G}{\partial V_{\text{BS}}} \right|_{\bar{V}=\bar{V}_Q} = 0$$

$$y_{21} = \left. \frac{\partial I_D}{\partial V_{\text{GS}}} \right|_{\bar{V}=\bar{V}_Q} = g_m \quad y_{22} = \left. \frac{\partial I_D}{\partial V_{\text{DS}}} \right|_{\bar{V}=\bar{V}_Q} = g_o \quad y_{23} = \left. \frac{\partial I_D}{\partial V_{\text{BS}}} \right|_{\bar{V}=\bar{V}_Q} = g_{mb}$$

$$y_{31} = \left. \frac{\partial I_B}{\partial V_{\text{GS}}} \right|_{\bar{V}=\bar{V}_Q} = 0 \quad y_{32} = \left. \frac{\partial I_B}{\partial V_{\text{DS}}} \right|_{\bar{V}=\bar{V}_Q} = 0 \quad y_{33} = \left. \frac{\partial I_B}{\partial V_{\text{GS}}} \right|_{\bar{V}=\bar{V}_Q} = 0$$



# Small-Signal 4-terminal Model Extension

$$I_D = \mu C_{ox} \frac{W}{2L} (V_{GS} - V_T)^2 \cdot (1 + \lambda V_{DS})$$

Definition:

$$V_{EB} = V_{GS} - V_T$$

$$V_{EBQ} = V_{GSQ} - V_{TQ}$$

$$V_T = V_{T0} + \gamma \left( \sqrt{\phi - V_{BS}} - \sqrt{\phi} \right)$$

$$g_m = \left. \frac{\partial I_D}{\partial V_{GS}} \right|_{\vec{V}=\vec{V}_Q} = \mu C_{ox} \frac{W}{2L} 2(V_{GS} - V_T)^1 \cdot (1 + \lambda V_{DS}) \Big|_{\vec{V}=\vec{V}_Q} \cong \mu C_{ox} \frac{W}{L} V_{EBQ}$$

Same as 3-term

$$g_o = \left. \frac{\partial I_D}{\partial V_{DS}} \right|_{\vec{V}=\vec{V}_Q} = \mu C_{ox} \frac{W}{2L} 2(V_{GS} - V_T)^2 \cdot \lambda \Big|_{\vec{V}=\vec{V}_Q} \cong \lambda I_{DQ}$$

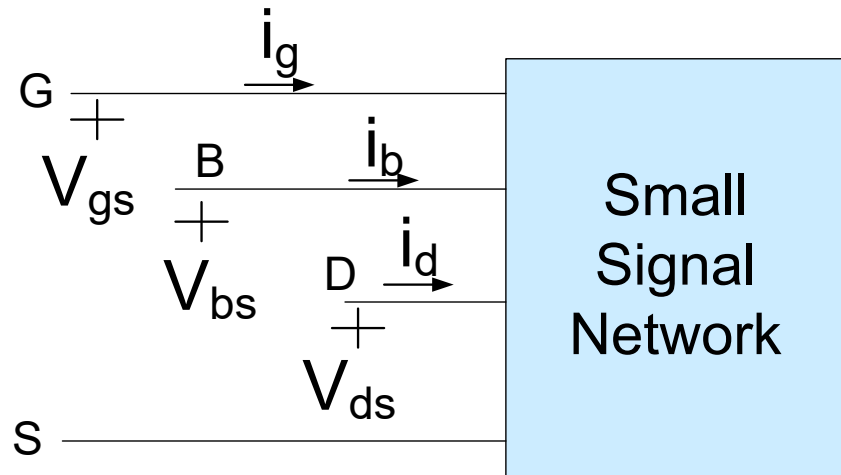
Same as 3-term

$$g_{mb} = \left. \frac{\partial I_D}{\partial V_{BS}} \right|_{\vec{V}=\vec{V}_Q} = \mu C_{ox} \frac{W}{2L} 2(V_{GS} - V_T)^1 \cdot \left( -\frac{\partial V_T}{\partial V_{BS}} \right) \cdot (1 + \lambda V_{DS}) \Big|_{\vec{V}=\vec{V}_Q}$$

$$g_{mb} = \left. \frac{\partial I_D}{\partial V_{BS}} \right|_{\vec{V}=\vec{V}_Q} \cong \mu C_{ox} \frac{W}{L} V_{EBQ} \cdot \left. \frac{\partial V_T}{\partial V_{BS}} \right|_{\vec{V}=\vec{V}_Q} = \left( \mu C_{ox} \frac{W}{L} V_{EBQ} \right) (-1) \gamma \frac{1}{2} (\phi - V_{BS})^{-\frac{1}{2}} \Big|_{\vec{V}=\vec{V}_Q} (-1)$$

$$g_{mb} \cong g_m \frac{\gamma}{2\sqrt{\phi - V_{BSQ}}}$$

# Small Signal 4-terminal MOSFET Model Summary



$$i_g = 0$$

$$i_b = 0$$

$$i_d = g_m v_{gs} + g_{mb} v_{bs} + g_o v_{ds}$$

$$g_m = \frac{\mu C_{ox} W}{L} v_{EBQ}$$

$$g_o = \lambda I_{DQ}$$

$$g_{mb} = g_m \left( \frac{\gamma}{2\sqrt{\phi - V_{BSQ}}} \right)$$

# Relative Magnitude of Small Signal MOS Parameters

Consider:

$$i_d = g_m v_{gs} + g_{mb} v_{bs} + g_o v_{ds}$$

3 alternate equivalent expressions for  $g_m$

$$g_m = \frac{\mu C_{ox} W}{L} V_{EBQ} \quad g_m = \sqrt{\frac{2\mu C_{ox} W}{L}} \sqrt{I_{DQ}} \quad g_m = \frac{2I_{DQ}}{V_{EBQ}}$$

Consider, as an example:

$$\mu C_{ox} = 100 \mu A/V^2, \lambda = .01 V^{-1}, \gamma = 0.4 V^{0.5}, V_{EBQ} = 1V, W/L = 1, V_{BSQ} = 0V$$

$$I_{DQ} \cong \frac{\mu C_{ox} W}{2L} V_{EBQ}^2 = \frac{10^{-4} W}{2L} (1V)^2 = 5E-5$$

$$g_m = \frac{\mu C_{ox} W}{L} V_{EBQ} = 1E-4$$

$$g_o = \lambda I_{DQ} = 5E-7$$

$$g_{mb} = g_m \left( \frac{\gamma}{2\sqrt{\phi - V_{BSQ}}} \right) = .26g_m$$

In this example

$$g_o \ll g_m, g_{mb}$$

$$g_{mb} < g_m$$

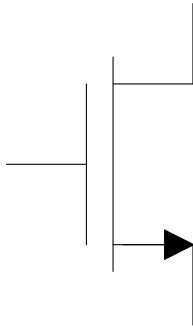
This relationship is common

In many circuits,  $V_{BS} = 0$  as well

- Often the  $g_o$  term can be neglected in the small signal model because it is so small
- Be careful about neglecting  $g_o$  prior to obtaining a final expression

# Large and Small Signal 4-Terminal MOSFET Model Summary

## Large Signal Model

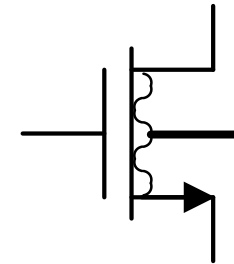


$$I_D = \begin{cases} 0 & V_{GS} \leq V_T \\ \mu C_{OX} \frac{W}{L} \left( V_{GS} - V_T - \frac{V_{DS}}{2} \right) V_{DS} & V_{GS} \geq V_T \quad V_{DS} < V_{GS} - V_T \\ \mu C_{OX} \frac{W}{2L} (V_{GS} - V_T)^2 \cdot (1 + \lambda V_{DS}) & V_{GS} \geq V_T \quad V_{DS} \geq V_{GS} - V_T \end{cases}$$

saturation

$$V_T = V_{T0} + \gamma \left( \sqrt{\phi - V_{BS}} - \sqrt{\phi} \right)$$

## Small Signal Model



saturation

$$i_g = 0$$

$$i_b = 0$$

$$i_d = g_m v_{gs} + g_{mb} v_{bs} + g_o v_{ds}$$

where

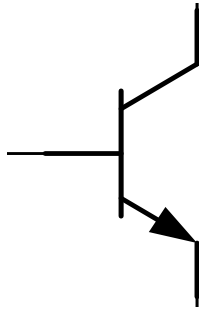
$$g_m = \frac{\mu C_{OX} W}{L} V_{EBQ}$$

$$g_{mb} = g_m \left( \frac{\gamma}{2\sqrt{\phi - V_{BSQ}}} \right)$$

$$g_o = \lambda I_{DQ}$$

# Large and Small Signal BJT Model Summary

Large Signal Model



$$I_C = \beta I_B \left( 1 + \frac{V_{CE}}{V_{AF}} \right)$$

$$I_B = \frac{J_S A_E}{\beta} e^{\frac{V_{BE}}{V_t}}$$

$$V_{BE} > 0.4V$$

$$V_{BC} < 0$$

Forward Active

$$V_{BE} = 0.7V$$

$$V_{CE} = 0.2V$$

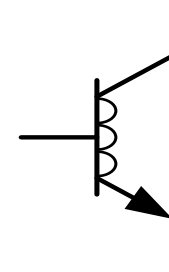
$$I_C < \beta I_B$$

$$I_C = I_B = 0$$

$$V_{BE} < 0$$

$$V_{BC} < 0$$

Small Signal Model



Forward Active

$$i_b = g_\pi v_{be}$$

$$i_c = g_m v_{be} + g_o v_{ce}$$

where

$$g_m = \frac{I_{CQ}}{V_t}$$

$$g_\pi = \frac{I_{CQ}}{\beta V_t}$$

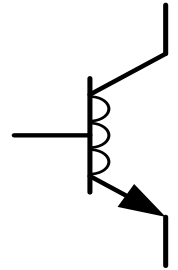
$$g_o \cong \frac{I_{CQ}}{V_{AF}}$$

# Relative Magnitude of Small Signal BJT Parameters

$$g_m = \frac{I_{CQ}}{V_t}$$

$$g_\pi = \frac{I_{CQ}}{\beta V_t}$$

$$g_o \cong \frac{I_{CQ}}{V_{AF}}$$



$$\frac{g_m}{g_\pi} = \frac{\left[ \frac{I_Q}{V_t} \right]}{\left[ \frac{I_Q}{\beta V_t} \right]}$$

$$\frac{g_\pi}{g_o} = \frac{\left[ \frac{I_Q}{\beta V_t} \right]}{\left[ \frac{I_Q}{V_{AF}} \right]}$$

$$g_m \gg g_\pi \gg g_o$$

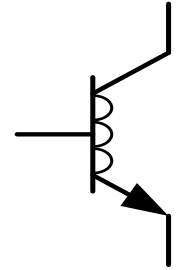
Often the  $g_o$  term can be neglected in the small signal model because it is so small

# Relative Magnitude of Small Signal Parameters

$$g_m = \frac{I_{CQ}}{V_t}$$

$$g_{\pi} = \frac{I_{CQ}}{\beta V_t}$$

$$g_o \cong \frac{I_{CQ}}{V_{AF}}$$



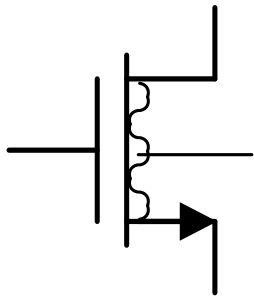
$$\frac{g_m}{g_{\pi}} = \frac{\left[ \frac{I_Q}{V_t} \right]}{\left[ \frac{I_Q}{\beta V_t} \right]} = \beta$$

$$\frac{g_{\pi}}{g_o} = \frac{\left[ \frac{I_Q}{\beta V_t} \right]}{\left[ \frac{I_Q}{V_{AF}} \right]} = \frac{V_{AF}}{\beta V_t} \approx \frac{200V}{100 \cdot 26mV} = 77$$

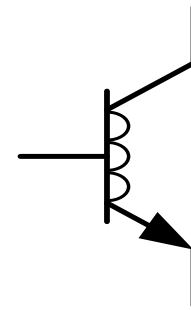
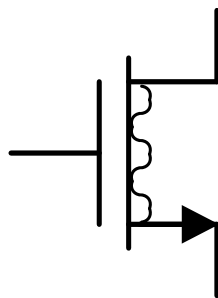
$$g_m \gg g_{\pi} \gg g_o$$

- Often the  $g_o$  term can be neglected in the small signal model because it is so small
- Be careful about neglecting  $g_o$  prior to obtaining a final expression

# Small Signal Model Simplifications for the MOSFET and BJT



MOSFET



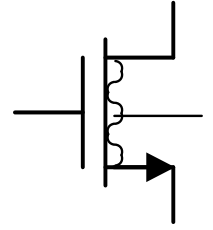
BJT

Often simplifications of the small signal model are adequate for a given application

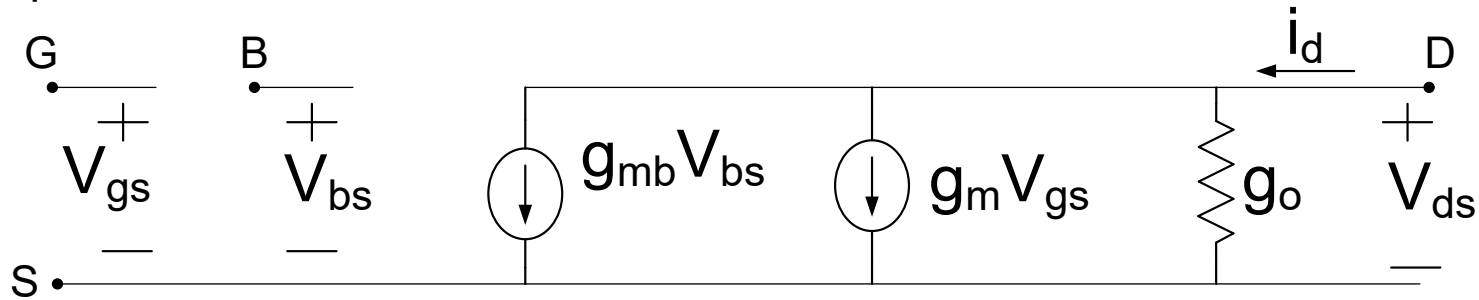
These simplifications will be discussed next



# Small Signal MOSFET Model Summary



An equivalent Circuit:



$$g_m = \frac{\mu C_{OX} W}{L} (V_{GSQ} - V_T)$$

$$g_o = \lambda I_{DQ}$$

$$g_{mb} = g_m \left( \frac{\gamma}{2\sqrt{\phi - V_{BSQ}}} \right)$$

**Alternate equivalent representations for  $g_m$**

$$g_m = \sqrt{\frac{2\mu C_{OX} W}{L}} \sqrt{I_{DQ}}$$

$$g_{mb} < g_m$$

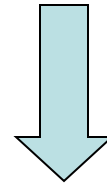
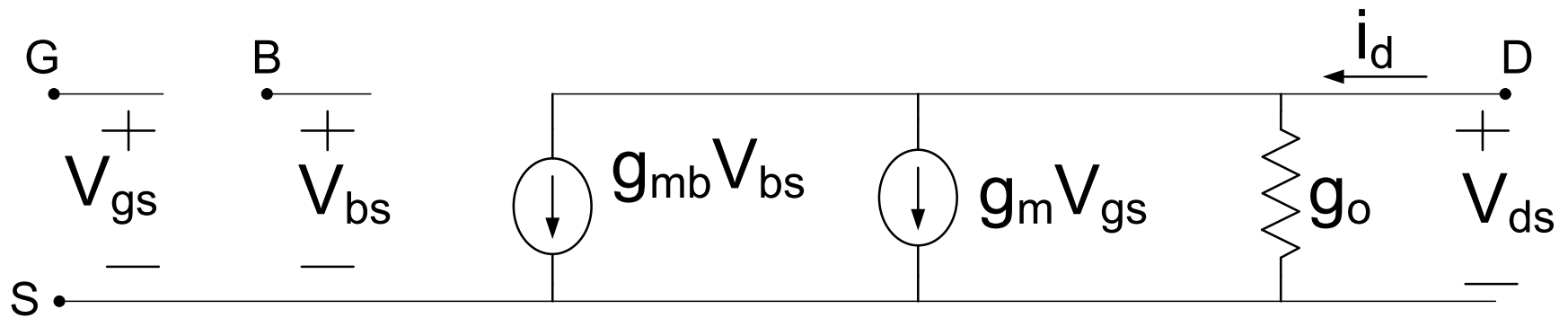
from  $I_D \cong \mu C_{OX} \frac{W}{2L} (V_{GS} - V_T)^2$

$$g_m = \frac{2I_{DQ}}{V_{GSQ} - V_T} = \frac{2I_{DQ}}{V_{EBQ}}$$

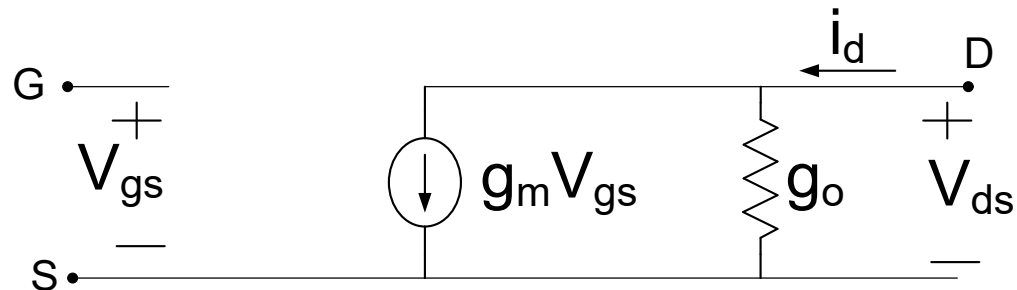
$$g_o \ll g_m, g_{mb}$$

**This contains absolutely no more information than the set of small-signal model equations**

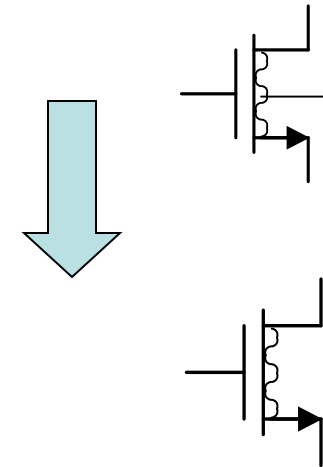
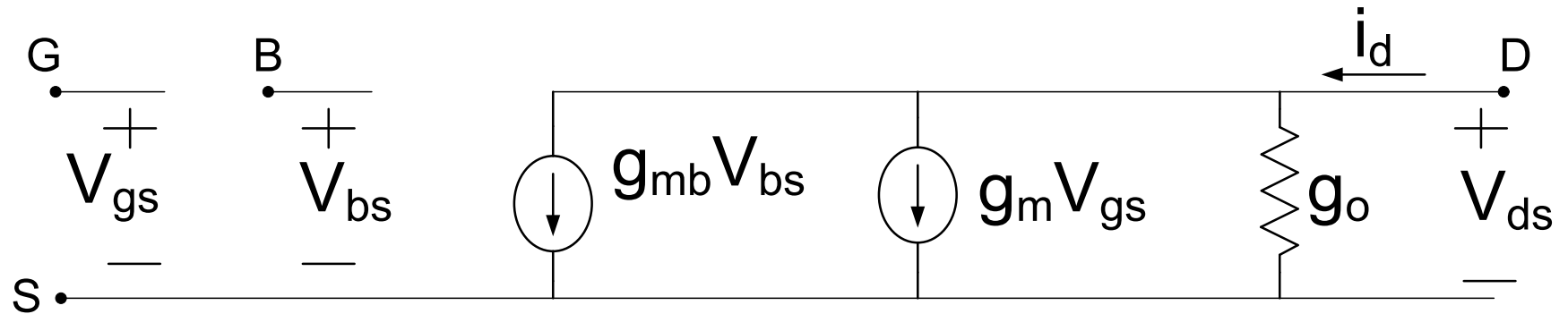
# Small Signal Model Simplifications



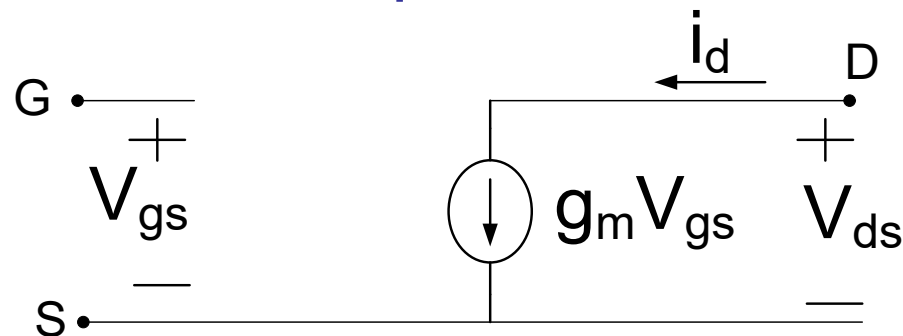
**Simplification that is often adequate**



# Small Signal Model Simplifications

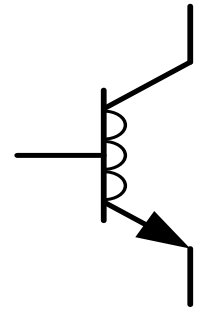
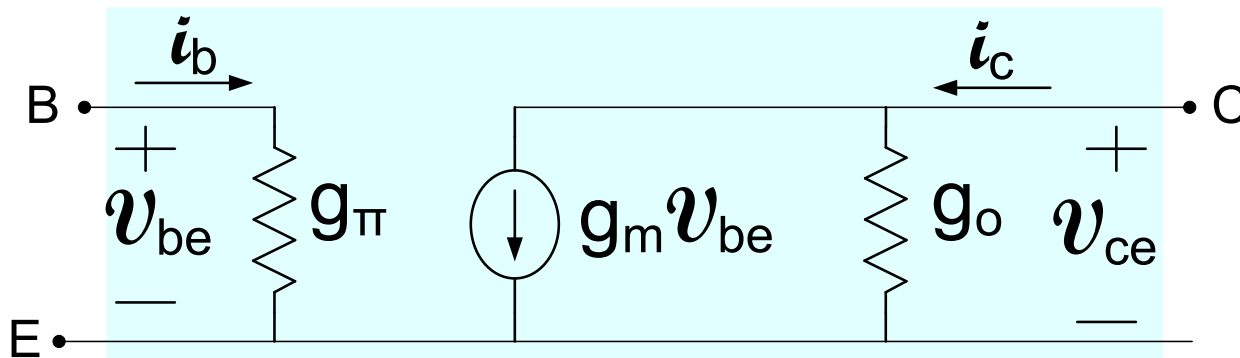


Even further simplification that is often adequate



# Small Signal BJT Model Summary

An equivalent circuit



$$g_m = \frac{I_{CQ}}{V_t}$$

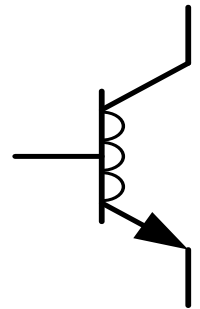
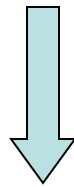
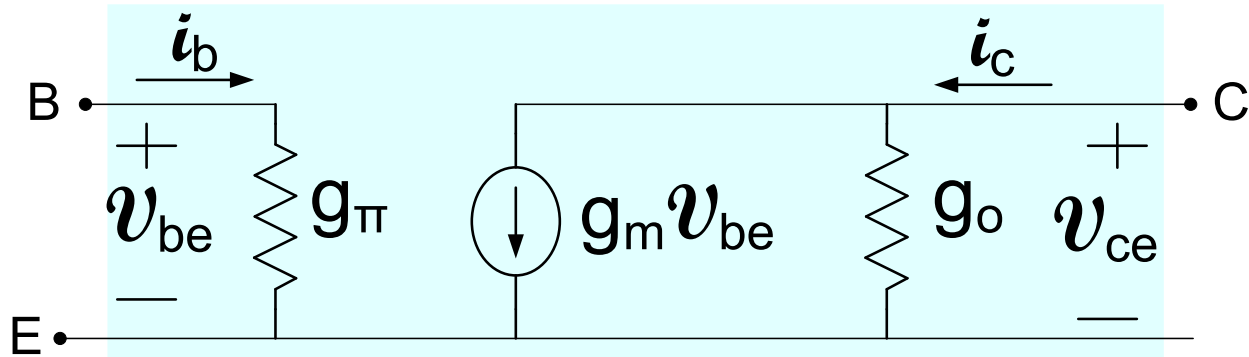
$$g_{\pi} = \frac{I_{CQ}}{\beta V_t}$$

$$g_o \cong \frac{I_{CQ}}{V_{AF}}$$

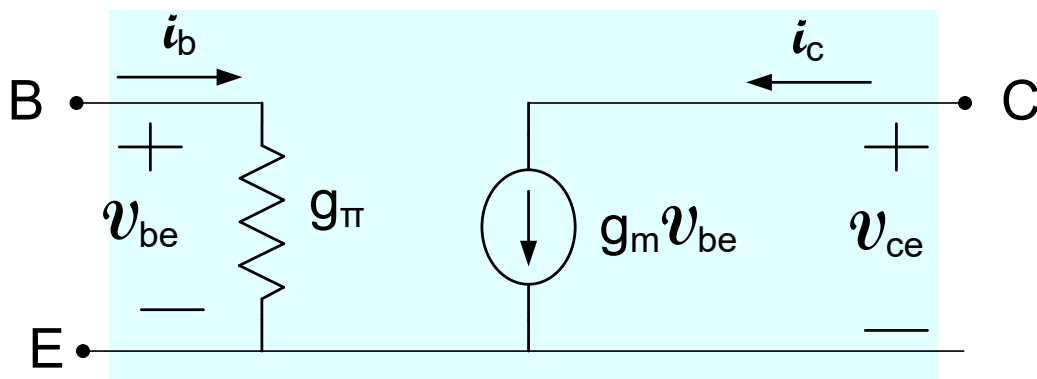
$$g_m \gg g_{\pi} \gg g_o$$

This contains absolutely no more information than the set of small-signal model equations

# Small Signal BJT Model Simplifications

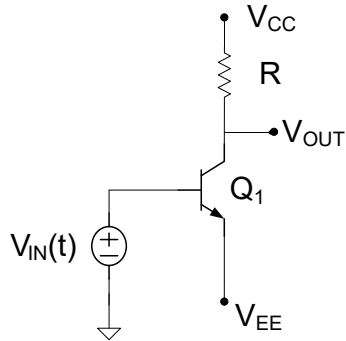


**Simplification that is often adequate**

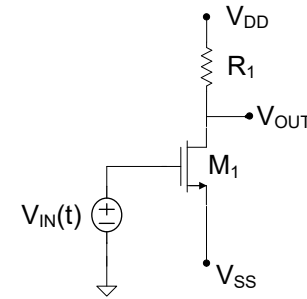


# Gains for MOSFET and BJT Circuits

## BJT



## MOSFET



$$A_{VB} = -\frac{I_{CQ} R_1}{V_t}$$

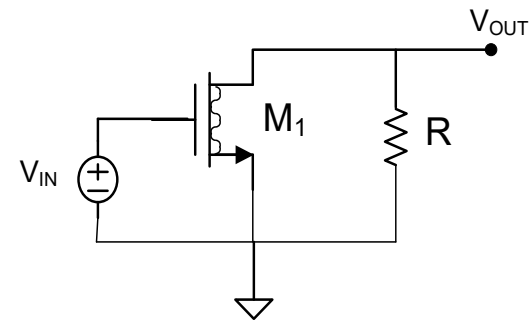
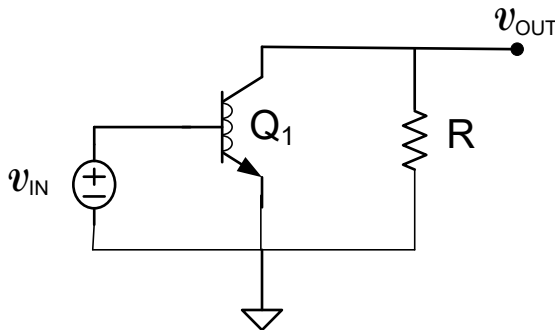
← Large Signal Parameter Domain →

$$A_{VM} = \frac{2I_{DQ} R}{[V_{SS} + V_T]}$$

For both circuits

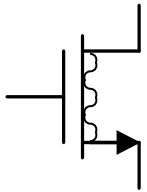
Small Signal Parameter Domain

$$A_v = -g_m R$$



- Gains are identical in small-signal parameter domain !
- Gains vary linearly with small signal parameter  $g_m$
- Power is often a key resource in the design of an integrated circuit
- In both circuits, power is proportional to  $I_{CQ}$ ,  $I_{DQ}$

# How does $g_m$ vary with $I_{DQ}$ ?



$$g_m = \sqrt{\frac{2\mu C_{ox} W}{L}} \sqrt{I_{DQ}}$$

Varies with the square root of  $I_{DQ}$

$$g_m = \frac{2I_{DQ}}{V_{GSQ} - V_T} = \frac{2I_{DQ}}{V_{EBQ}}$$

Varies linearly with  $I_{DQ}$

$$g_m = \frac{\mu C_{ox} W}{L} (V_{GSQ} - V_T)$$

Doesn't vary with  $I_{DQ}$

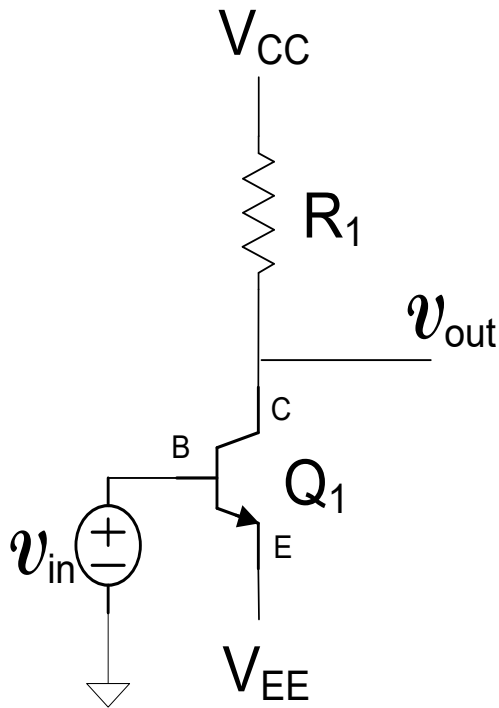
# How does $g_m$ vary with $I_{DQ}$ ?

All of the above are true – but with qualification

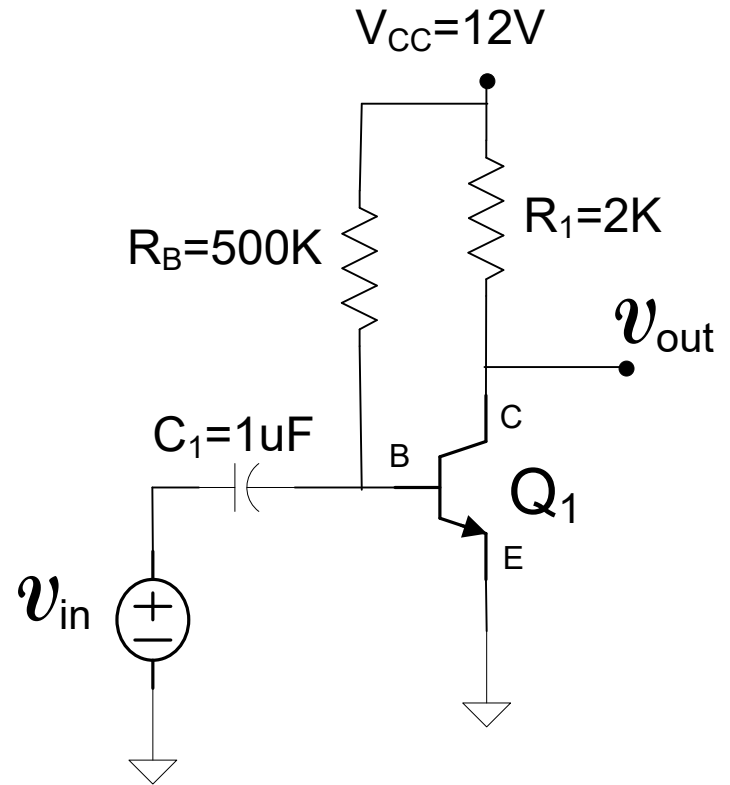
$g_m$  is a function of more than one variable ( $I_{DQ}$ ) and how it varies depends upon how the remaining variables are constrained



# Amplifier Biasing (precursor)



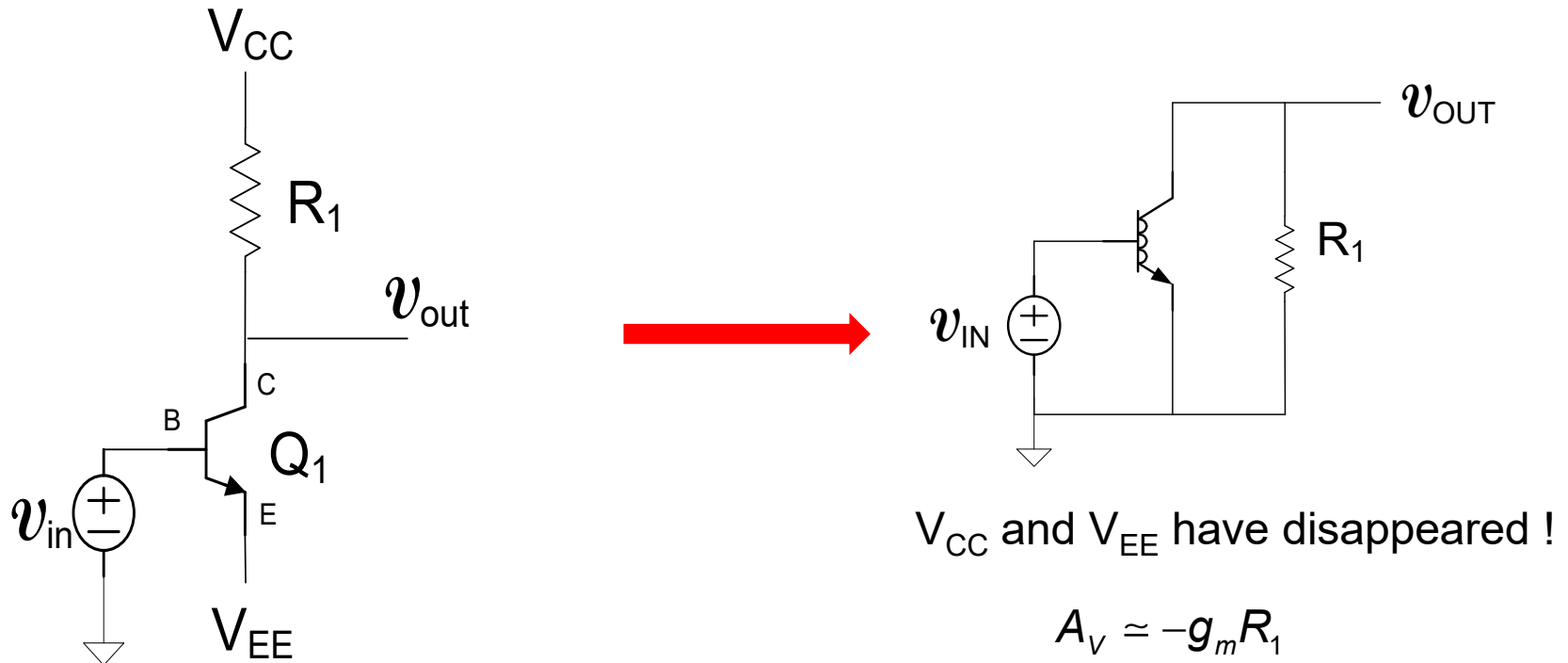
Not convenient to have multiple dc power supplies  
 $V_{OUTQ}$  very sensitive to  $V_{EE}$



Single power supply  
Additional resistor and capacitor

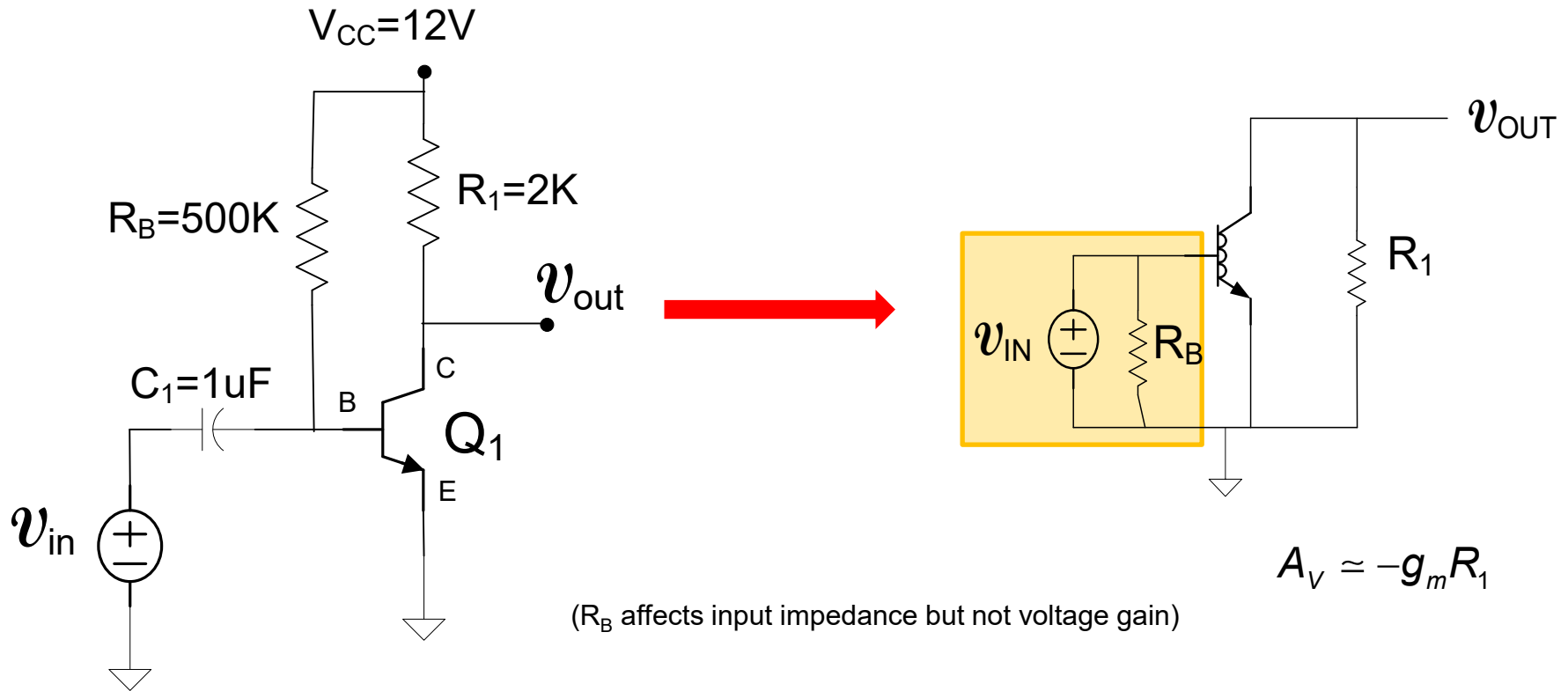
Compare the small-signal equivalent circuits of these two structures  
Compare the small-signal voltage gain of these two structures

# Amplifier Biasing (precursor)



- Voltage sources  $V_{EE}$  and  $V_{CC}$  used for biasing
  - Not convenient to have multiple dc power supplies
  - $V_{OUTQ}$  very sensitive to  $V_{EE}$
- 
- Biasing is used to obtain the desired operating point of a circuit
  - Ideally the biasing circuit should not distract significantly from the basic operation of the circuit

# Amplifier Biasing (precursor)



**Single power supply**

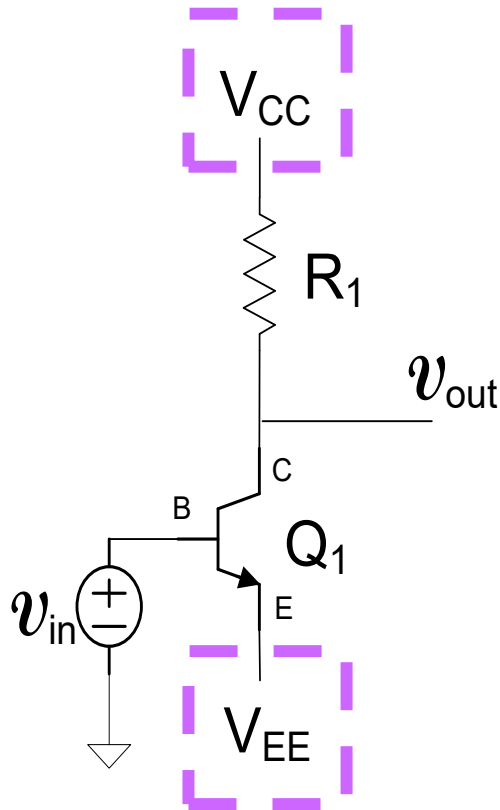
**Additional resistor and capacitor**

**Thevenin Equivalent of  $v_{IN}$  &  $R_B$  is  $v_{IN}$**

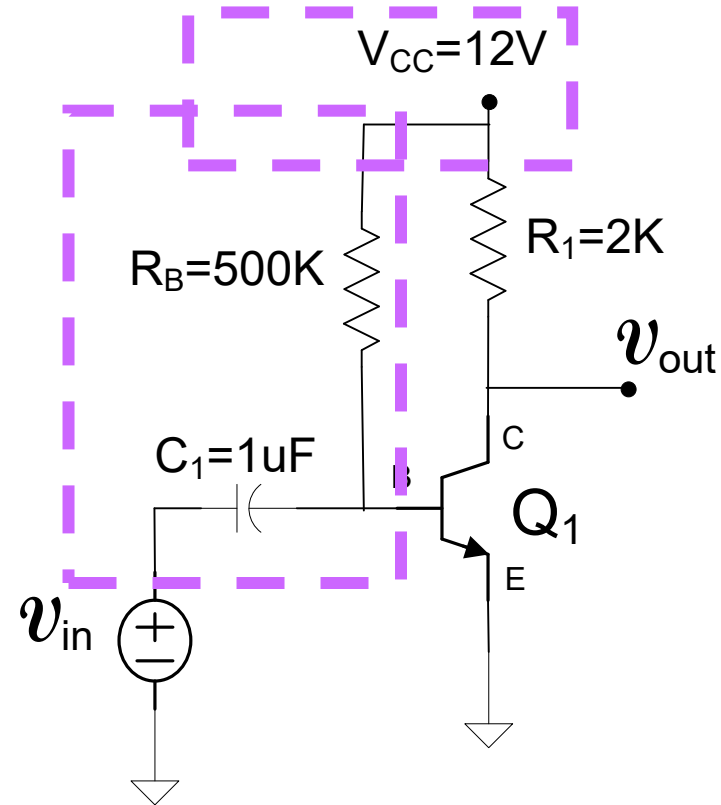
- Biasing is used to obtain the desired operating point of a circuit
- Ideally the biasing circuit should not distract significantly from the basic operation of the circuit

# Amplifier Biasing (precursor)

Biasing Circuits shown in purple

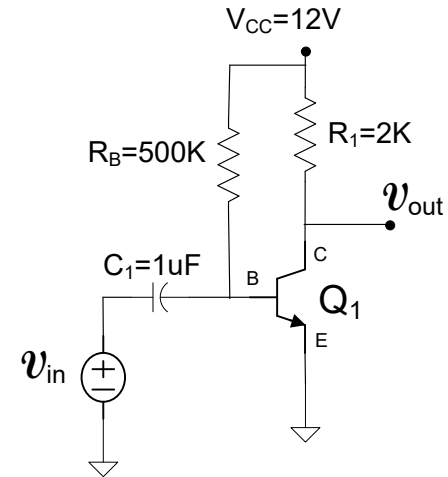
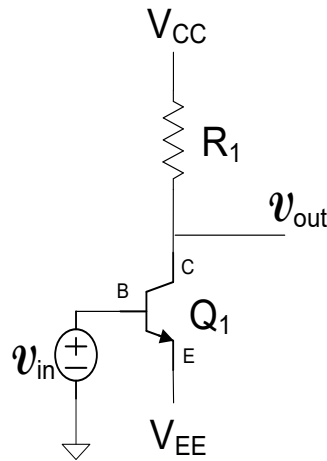


Not convenient to have multiple dc power supplies  
 $V_{OUTQ}$  very sensitive to  $V_{EE}$

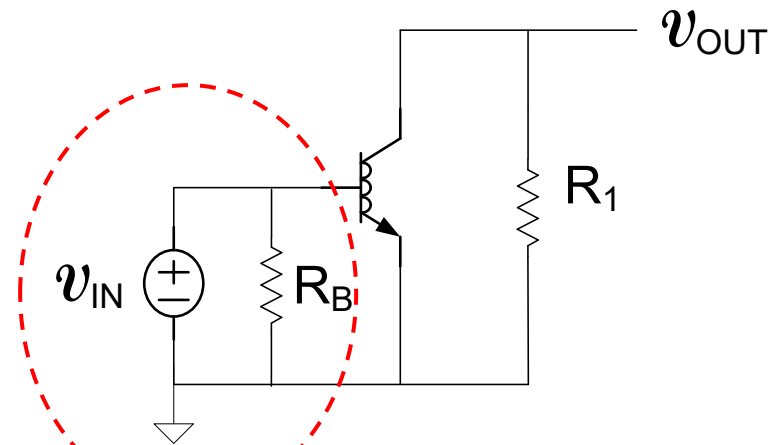
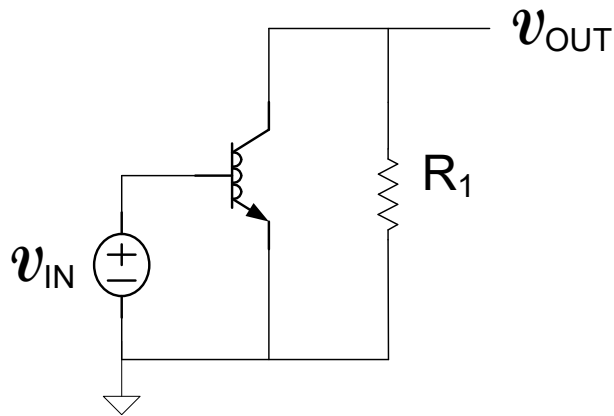


Single power supply  
Additional resistor and capacitor

# Amplifier Biasing (precursor)



Compare the small-signal equivalent circuits of these two structures



Since Thevenin equivalent circuit in red circle is  $V_{IN}$ , both circuits have same voltage gain

But the load placed on  $V_{IN}$  is different

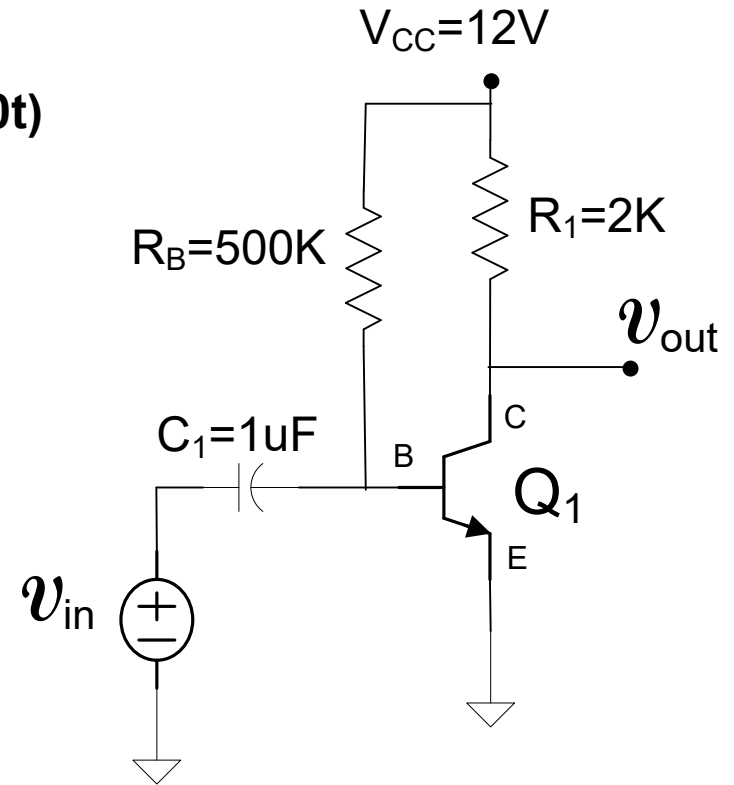
**Method of characterizing the amplifiers is needed to assess impact of difference**

# Amplifier Characterization (an example)

This example serves as a precursor to amplifier characterization

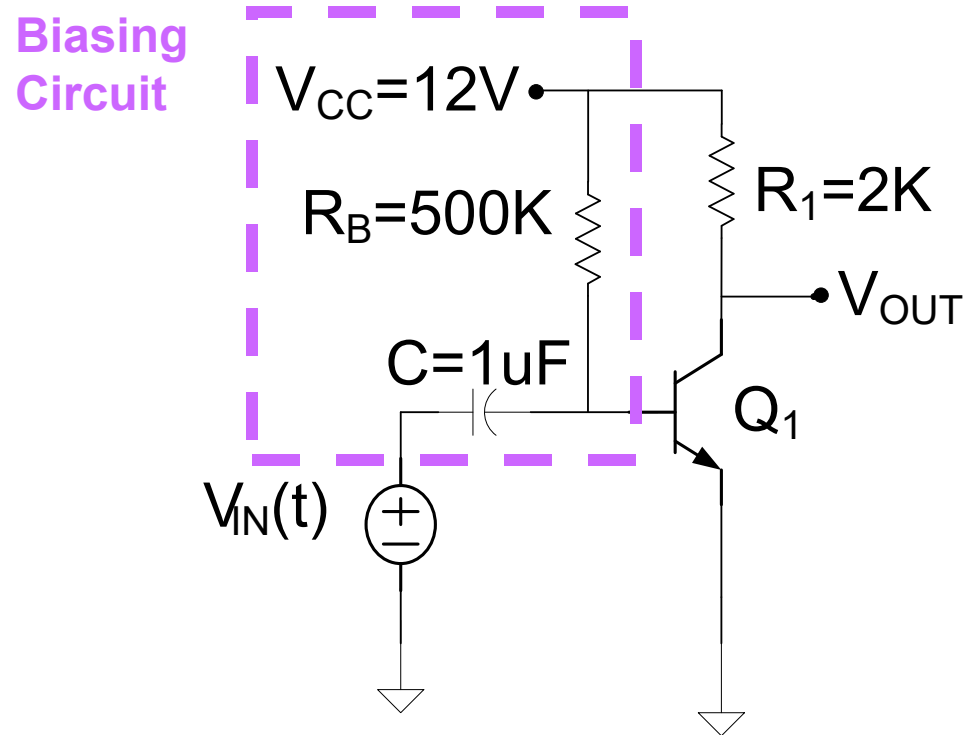
Determine  $V_{OUTQ}$ ,  $A_V$ ,  $R_{IN}$  Assume  $\beta=100$

Determine  $v_{OUT}$  and  $V_{OUT}(t)$  if  $v_{IN}=.002\sin(400t)$



In the following slides we will analyze this circuit

# Amplifier Characterization (an example)



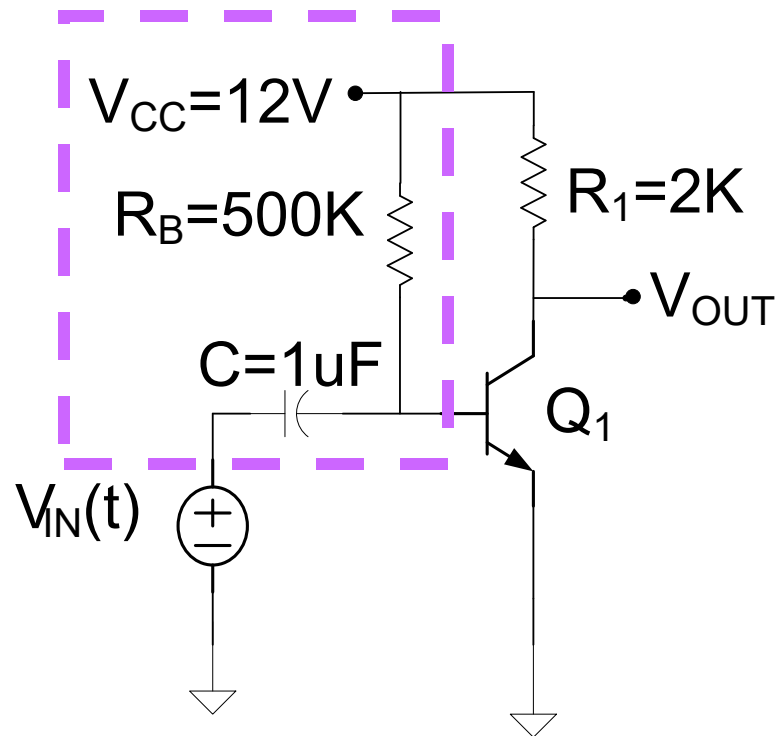
(biasing components:  $C$ ,  $R_B$ ,  $V_{CC}$  in this case, all disappear in small-signal gain circuit)

Several different biasing circuits can be used

# Amplifier Characterization (an example)

Determine  $V_{OUTQ}$ ,  $A_V$ ,  $R_{IN}$

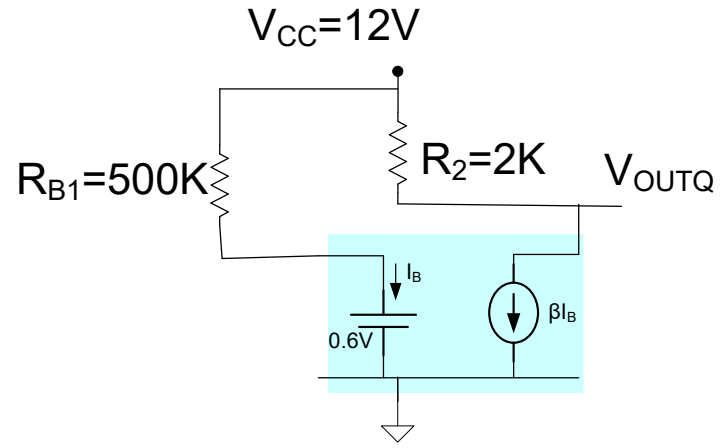
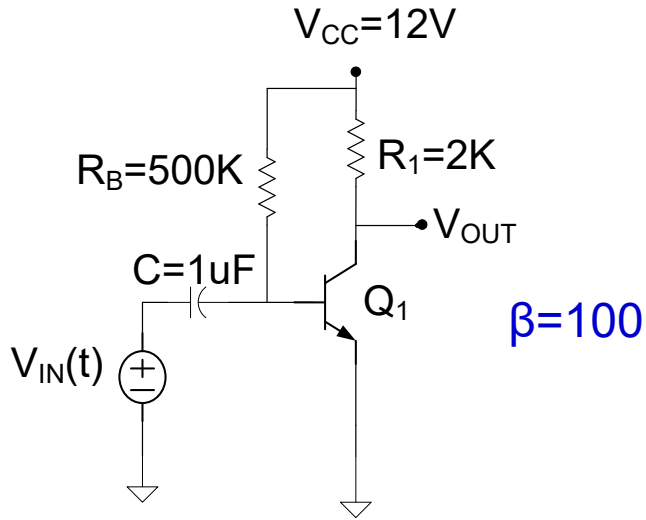
Biassing  
Circuit





# Amplifier Characterization (an example)

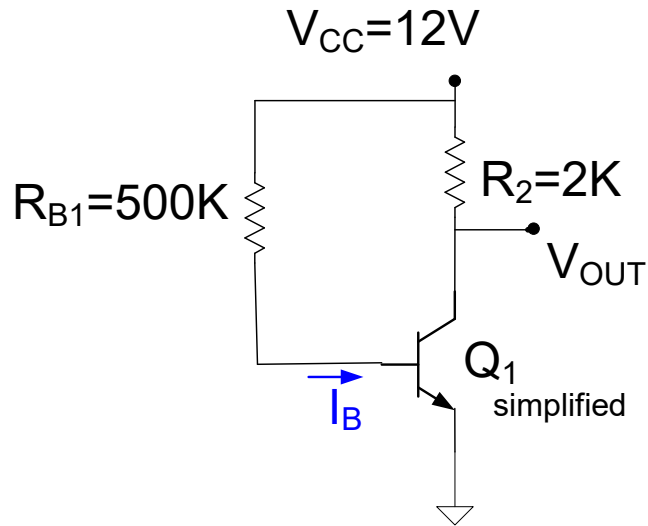
Determine  $V_{OUTQ}$



dc equivalent circuit

$$I_{CQ} = \beta I_{BQ} = 100 \left( \frac{12V - 0.6V}{500K} \right) = 2.3mA$$

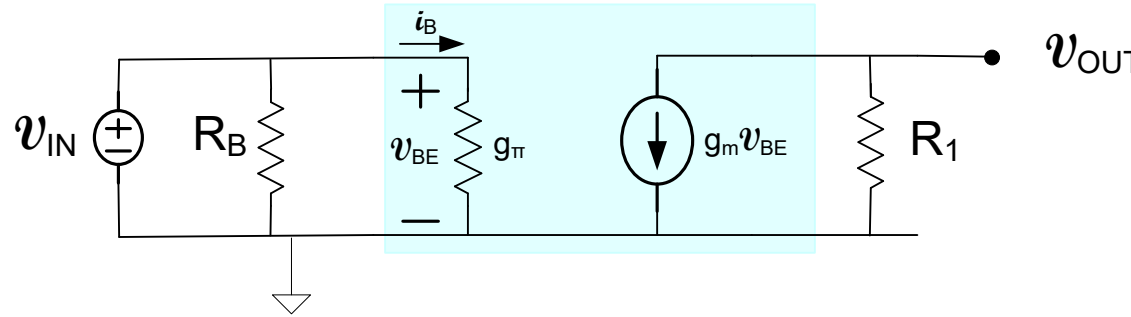
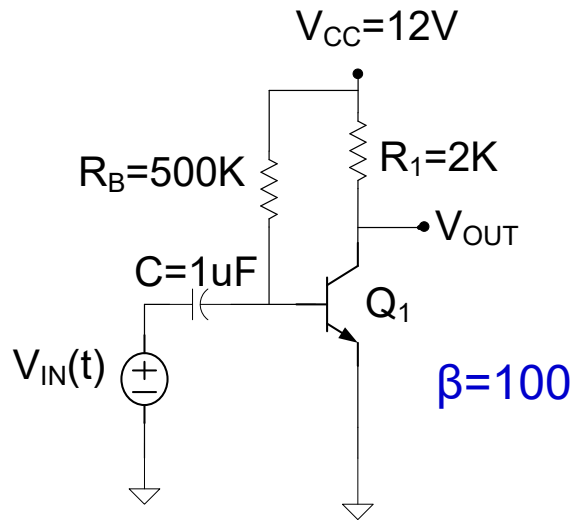
$$V_{OUTQ} = 12V - I_{CQ} R_1 = 12V - 2.3mA \cdot 2K = 7.4V$$



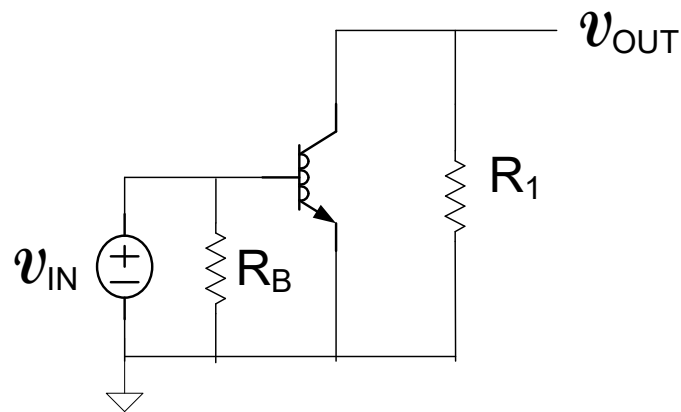
dc equivalent circuit

# Amplifier Characterization (an example)

Determine the SS voltage gain ( $A_V$ )



ss equivalent circuit



ss equivalent circuit

$$\left. \begin{aligned} v_{OUT} &= -g_m v_{BE} R_1 \\ v_{IN} &= v_{BE} \end{aligned} \right\}$$

$$A_V = -R_1 g_m$$

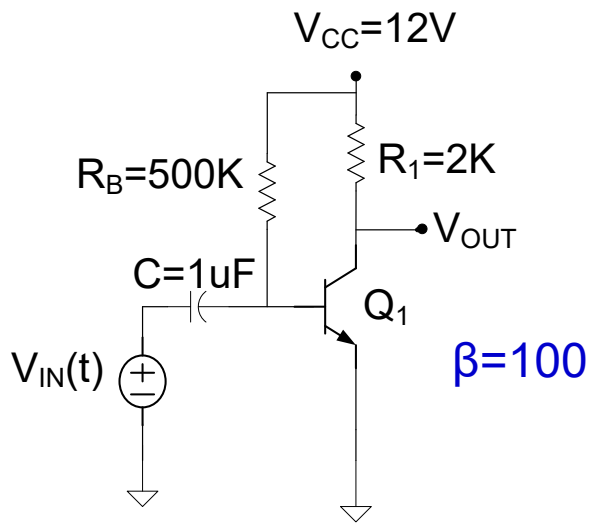
$$A_V \cong -\frac{I_{CQ} R_1}{V_t}$$

$$A_V \cong -\frac{2.3\text{mA} \cdot 2\text{K}}{26\text{mV}} \cong -177$$

This basic amplifier structure is widely used and repeated analysis serves no useful purpose

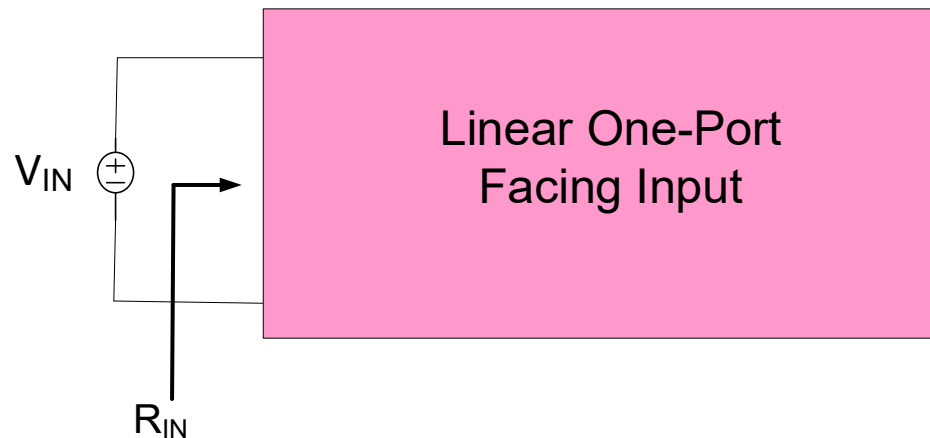
Have seen this circuit before but will repeat for review purposes

# Amplifier Characterization (an example)



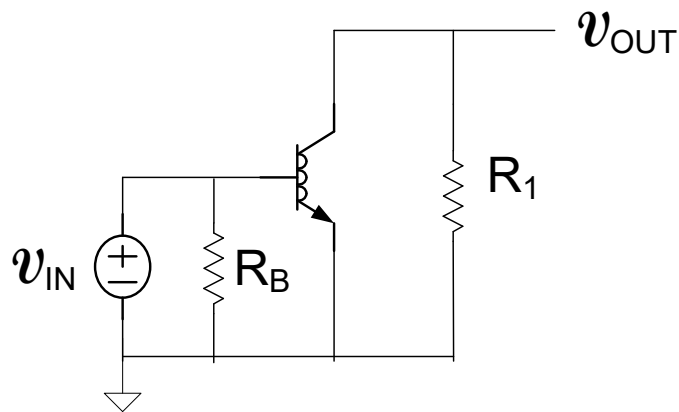
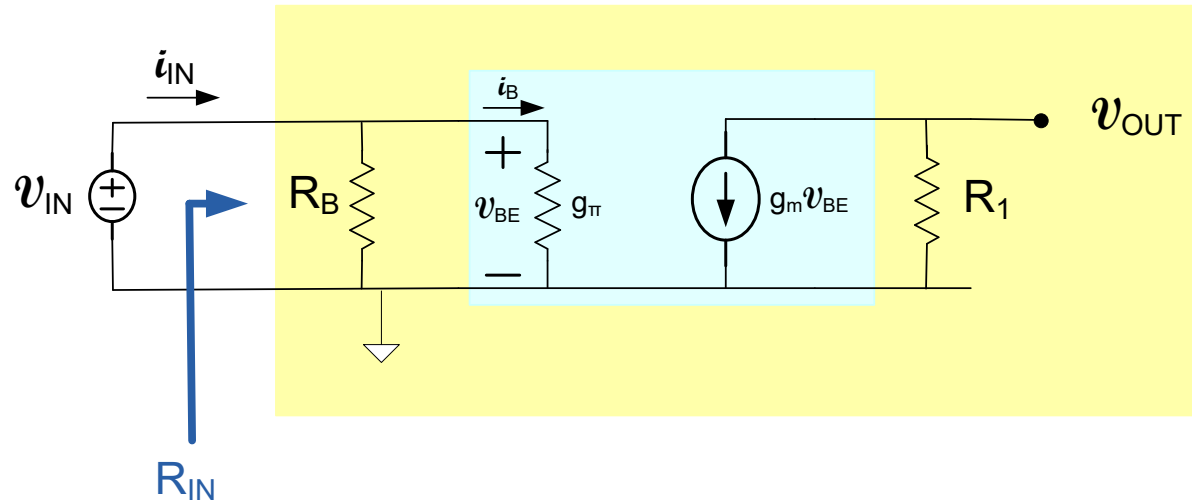
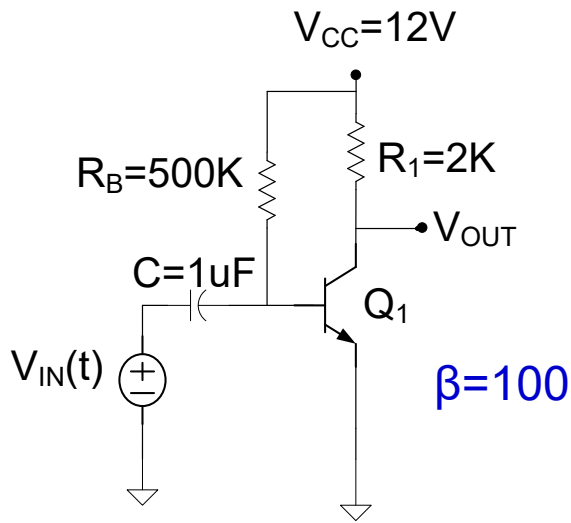
Determine  $V_{OUTQ}$ ,  $A_V$ ,  $R_{IN}$  ✓

- Here  $R_{IN}$  is defined to be the impedance facing  $V_{IN}$
- Here any load is assumed to be absorbed into the one-port
- Later will consider how load is connected in defining  $R_{IN}$



# Amplifier Characterization (an example)

Determine  $R_{IN}$



ss equivalent circuit

$$R_{in} = \frac{v_{IN}}{i_{IN}}$$

$$R_{in} = R_B // r_{\pi}$$

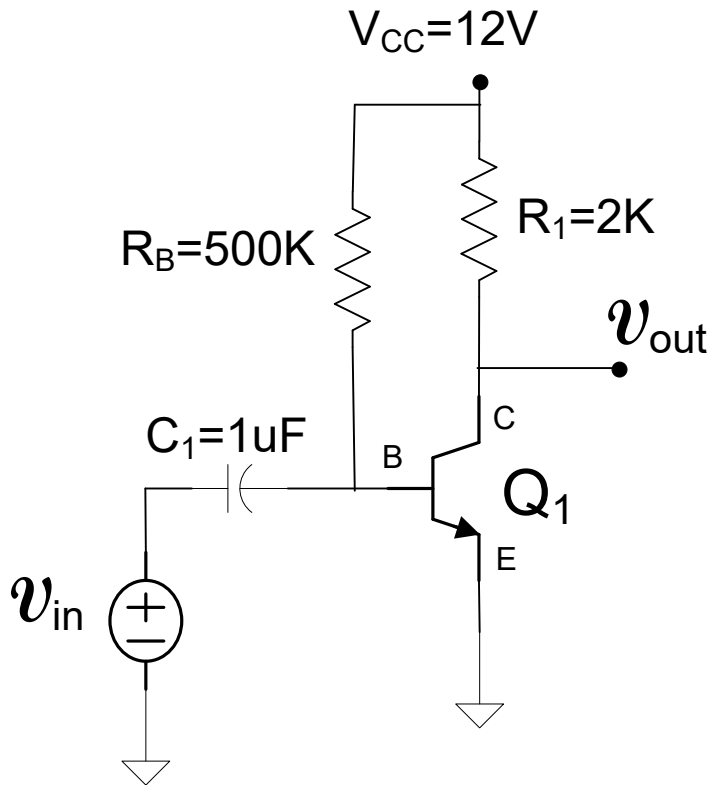
Usually  $R_B \gg r_{\pi}$

$$R_{in} = R_B // r_{\pi} \cong r_{\pi}$$

$$R_{in} \cong r_{\pi} = \frac{I_{CQ}}{\beta V_t}$$

# Amplifier Characterization (an example)

Determine  $v_{OUT}$  and  $V_{OUT}(t)$  if  $v_{IN} = .002\sin(400t)$



$$v_{OUT} = A_V v_{IN}$$

$$v_{OUT} = -177 \cdot .002 \sin(400t) = -0.354 \sin(400t)$$

$$V_{OUT}(t) \cong V_{OUTQ} + A_V v_{IN}$$

$$V_{OUT} \cong 7.4V - 0.35 \cdot \sin(400t)$$

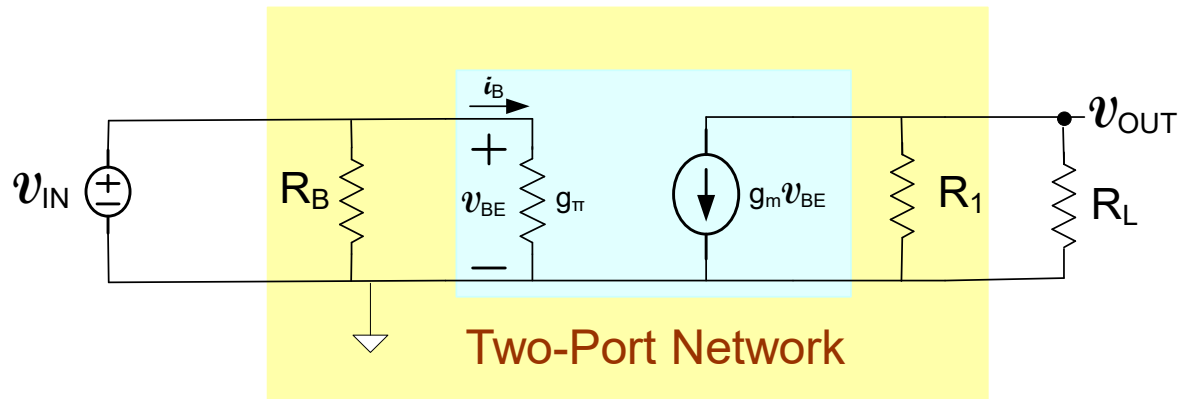
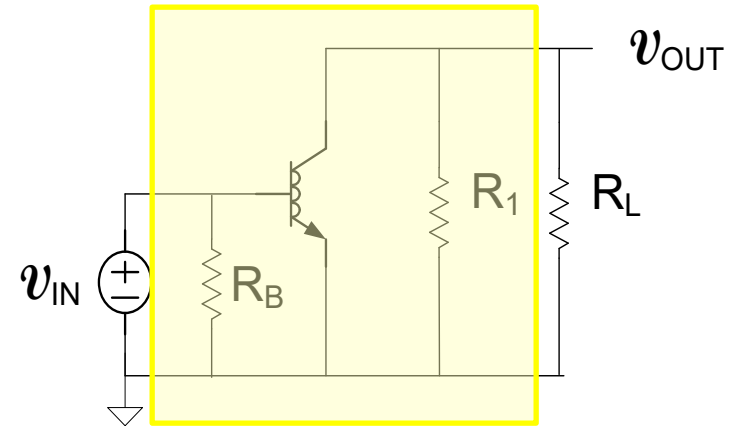
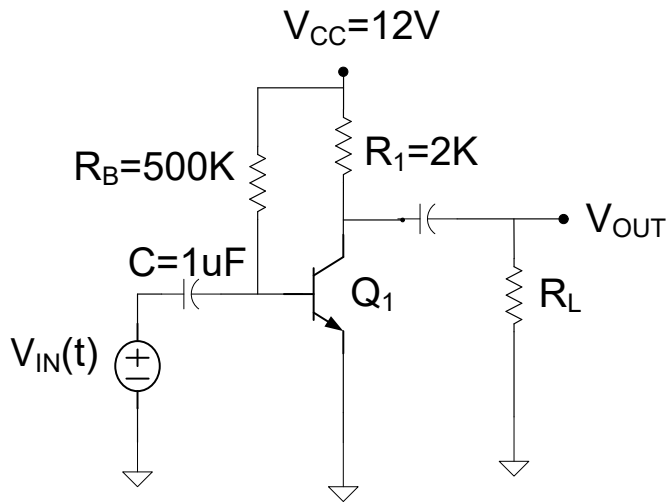
This example identified several useful characteristics of amplifiers but a more formal method of characterization is needed!

# Amplifier Characterization

- Two-Port Models
- Amplifier Parameters

Will assume amplifiers have two ports, one termed an input port and the other termed an output port

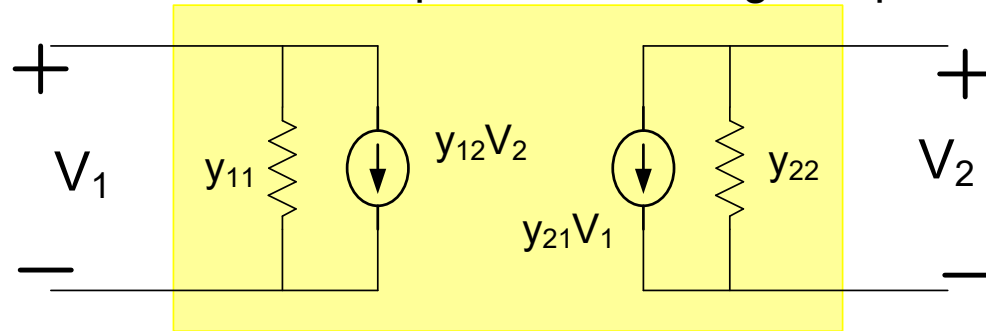
# Two-Port Representation of Amplifiers



- Two-port model representation of amplifiers useful for insight into operation and analysis
- Internal components to the two-port can be quite complicated but equivalent two-port model is quite simple

# Two-port representation of amplifiers

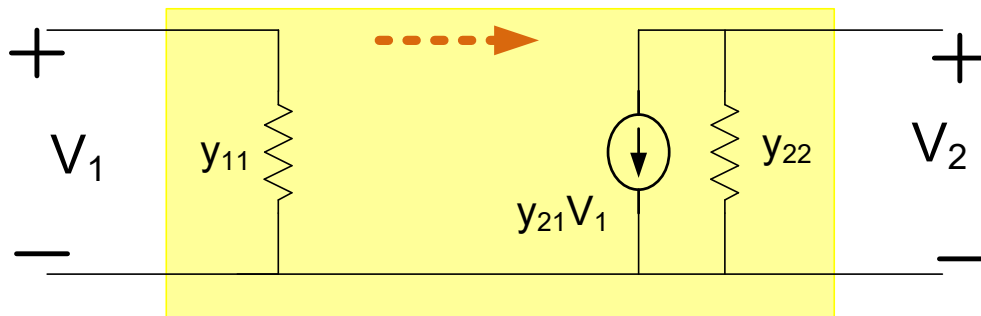
Amplifiers can be modeled as a two-port for small-signal operation



In terms of y-parameters

Other parameter sets could be used

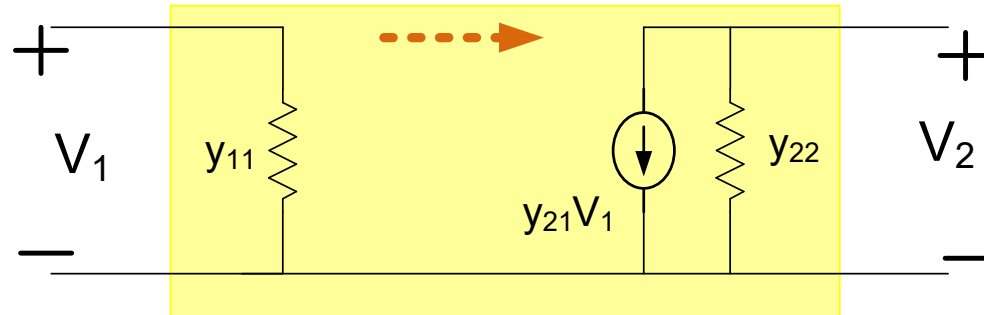
- Amplifier often **unilateral** (signal propagates in only one direction: wlog  $y_{12}=0$ )
- One terminal is often common



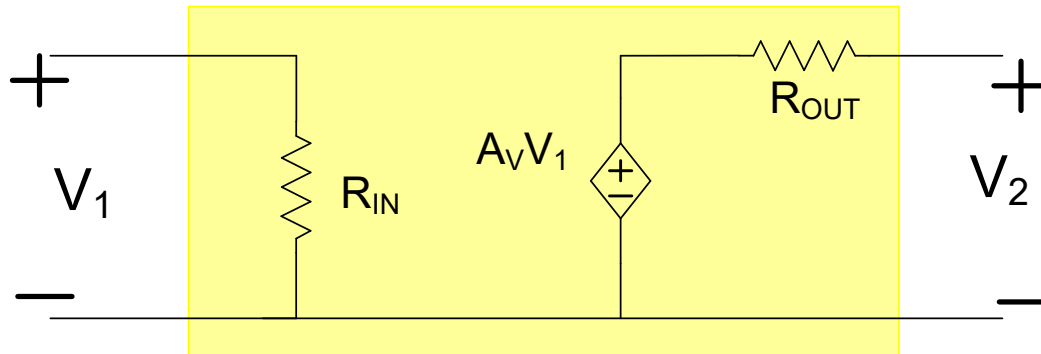


# Two-port representation of amplifiers

## Unilateral amplifiers:



- Thevenin equivalent output port often more standard
- $R_{IN}$ ,  $A_V$ , and  $R_{OUT}$  often used to characterize the two-port of amplifiers



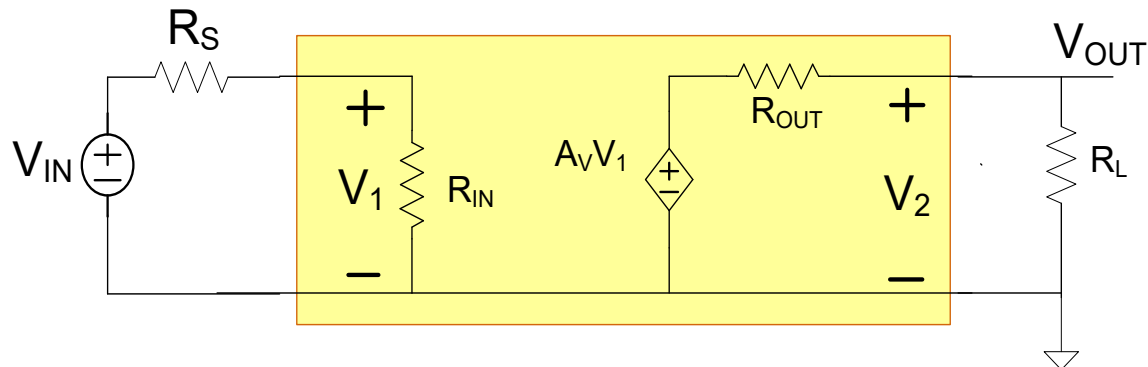
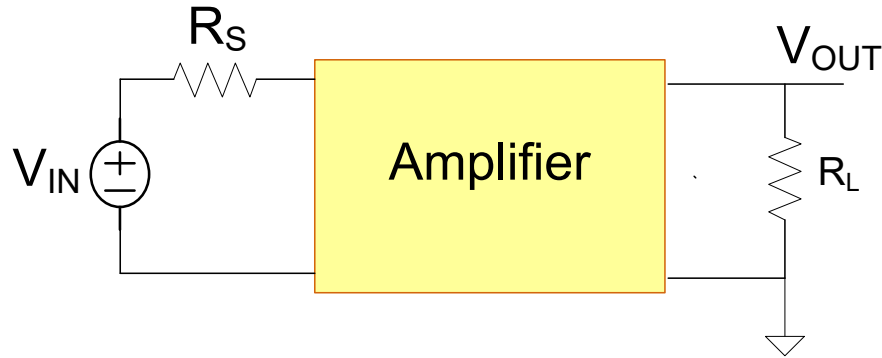
Unilateral amplifier in terms of “amplifier” parameters

$$R_{IN} = \frac{1}{y_{11}} \quad A_V = -\frac{y_{21}}{y_{22}} \quad R_{OUT} = \frac{1}{y_{22}}$$

# Amplifier input impedance, output impedance and gain are usually of interest

Why?

Example 1: Assume amplifier is unilateral



$$V_{OUT} = \left( \frac{R_L}{R_L + R_{OUT}} \right) A_V \left( \frac{R_{IN}}{R_S + R_{IN}} \right) V_{IN}$$

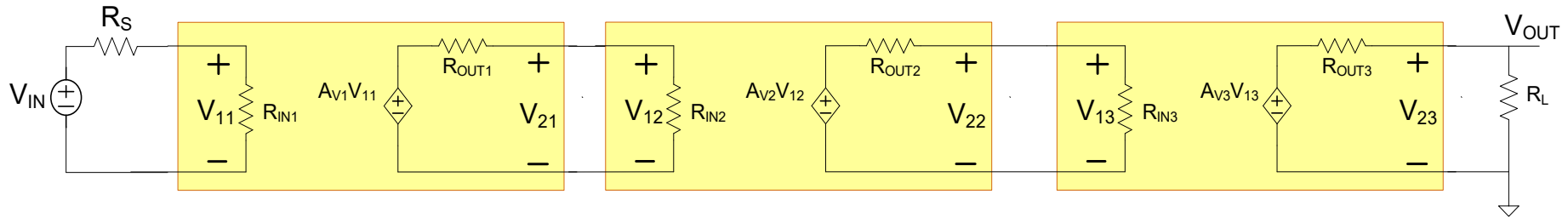
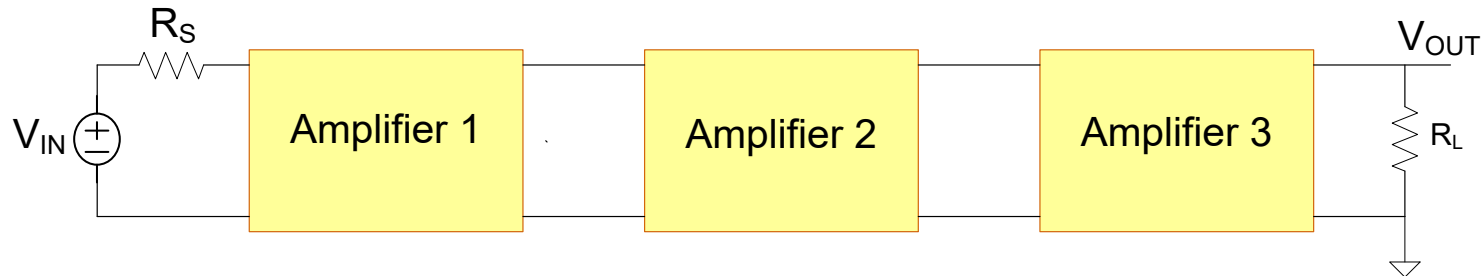
$$A_{VAMP} = \frac{V_{OUT}}{V_{IN}} = \left( \frac{R_L}{R_L + R_{OUT}} \right) \left( \frac{R_{IN}}{R_S + R_{IN}} \right) A_V$$

- Can get gain without reconsidering details about components internal to the Amplifier !!!
- Analysis more involved when not unilateral

# Amplifier input impedance, output impedance and gain are usually of interest

Why?

Example 2: Assume amplifiers are unilateral



$$V_{OUT} = \left( \frac{R_L}{R_L + R_{OUT3}} \right) A_{V3} \left( \frac{R_{IN3}}{R_{OUT2} + R_{IN3}} \right) A_{V2} \left( \frac{R_{IN2}}{R_{OUT1} + R_{IN2}} \right) A_{V1} \left( \frac{R_{IN1}}{R_S + R_{IN1}} \right) V_{IN}$$

$$A_{VAMP} = \frac{V_{OUT}}{V_{IN}} = \left( \frac{R_L}{R_L + R_{OUT3}} \right) A_{V3} \left( \frac{R_{IN3}}{R_{OUT2} + R_{IN3}} \right) A_{V2} \left( \frac{R_{IN2}}{R_{OUT1} + R_{IN2}} \right) A_{V1} \left( \frac{R_{IN1}}{R_S + R_{IN1}} \right)$$

- Can get gain without reconsidering details about components internal to the Amplifier !!!
- Analysis more involved when not unilateral



Stay Safe and Stay Healthy !

End of Lecture 27